

# CMX backplane tests

Chip Brock, Dan Edmunds, Philippe Laurens,  
Savanna Shaw, Yuri Ermoline, Jim Linnemann, **Duc Bao Ta - MSU**  
Wojciech Fedorko - UBC  
Pawel Plucinski - Stockholm University  
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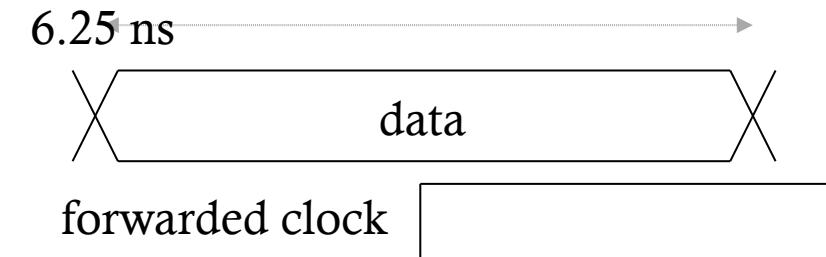
# CMX used for backplane test

- **Two CMX boards at CERN**
  - SN01: Base and Topo FPGA
  - SN03: Base FPGA only
- **Both operated in B104 test crate with three JEMs and two CPMs**
  - Firmware and software developed and available for backplane tests
    - Debugging code, development of test procedures
- **Both CMX were tested in USA15, JEP0 crate with 16 JEMs, CP0 crate with 14 CPMs**
  - Test for powering problems, heat etc.
  - Test backplane data transmission fidelity at 160 Mbps/signal
    - Data integrity, data stability: good and wide timing window (bathtub curve), long term data stability (BER)
- **Both boards are still at CERN for further tests and developments**

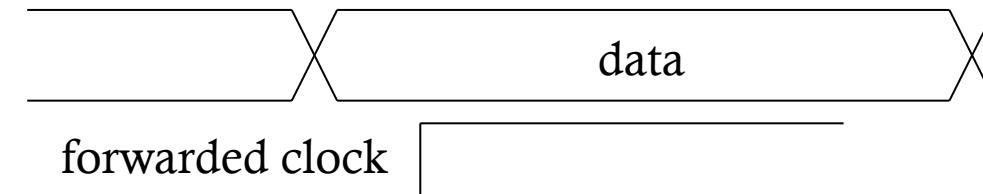
# Timing shift setup

- CMX has independent delay circuits in 31 taps à ~78ps, window of 4.8ns in total
  - for each 400 backplane lines ( $16 \times (24 \text{ [data]} + 1 \text{ [source synchronous clock]})$ )

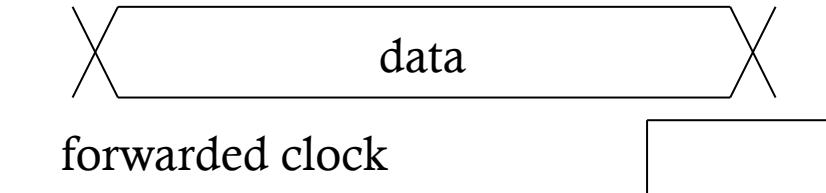
nominal (all taps 0)



data max delay

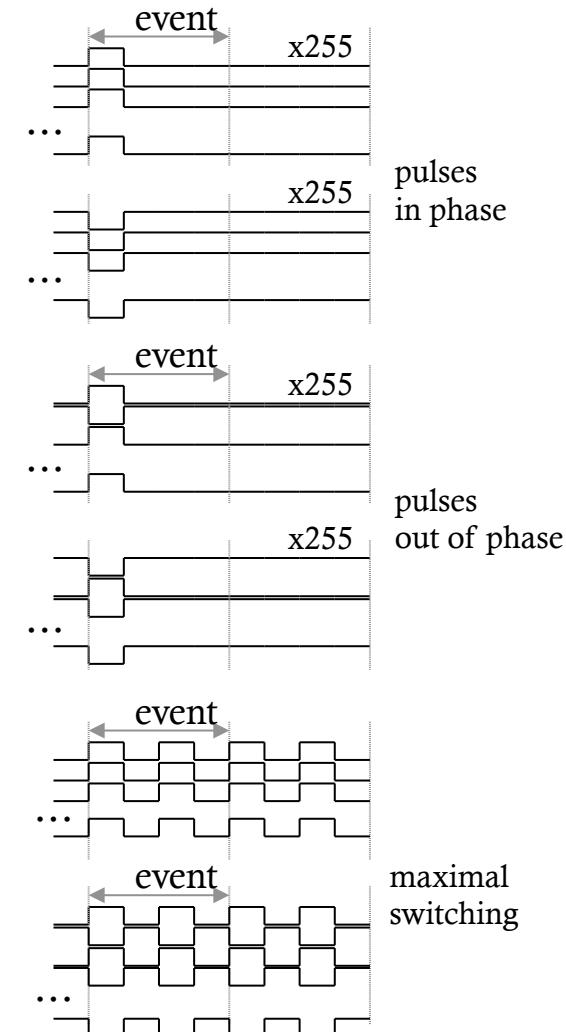


clock max delay



# Stress patterns

- **55 stress patterns with a 256 event cycle**
  - Each event has 4 event words, i.e. 24bit  $x 4 = 96$ bits per source channel
  - Firmware configuration of JEMs (both SumET and Jet FPGA) and CPMs updated to send patterns at 160Mbps
  - Patterns do not have defined parity
- **Pattern with pulses (50 patterns)**
  - Pulse on the first event word, then silence on other event words and events
  - Switching all bits *in phase* (2 patterns)
  - Switching of single bits *out of phase* (24 + 24 pattern)
- **Other types of patterns (5 patterns)**
  - *Maximal switching* all bits in phase, even bits out of phase with odd bits
  - Special patterns to detect event word position (3 patterns)
- **Pseudo-random data**
  - JEM; Array of 47-bit LFSR running in parallel (different firmware)
  - CPM: Single 95-bit LFSR, advance a full word after each event (same firmware)
  - Generated with odd parity to check for parity errors



# Test capabilities and setup

- **Test capabilities**
  - CMX firmware compares data inputs with spy memory with pattern loaded externally
  - **Data comparison: flags bit errors on each data bit** per input channel, *used for pattern tests*
  - **Parity errors per channel**, *used for pseudo-random data tests*
  - Counters for number of events until a bit error has been found in one channel and number of events
- **Synchronization of patterns**
  - CMX comparison synchronized via BC reset signal
  - JEM pattern generation synchronized via BC reset signal, different arrival times compensated on CMX via adjustable start addresses for comparison
  - CPM synchronization via “random” resets until synchronized arrival of data at CMX is achieved
- **Additional stress test from CMX LVDS drivers, but no actual data is send out**
  - FPGA outputs normally driving all 5 LVDS lines sending a stress pattern in sync
    - Long silences all at '0', all at '1', all pulsing '1', all pulsing '0', switching
    - High drive current (12 mA)
  - Aims to disturb ground reference of the FPGA potentially affecting CMOS input timing and 255 events long (aims to create 'beats')

# Timing scans with patterns

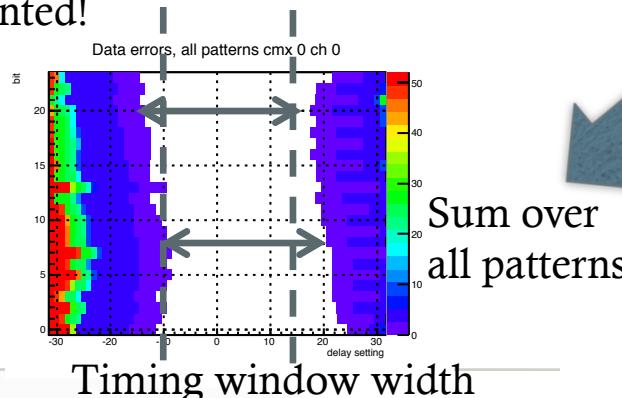
- Scan over delays on the data lines and clock lines using patterns
  - One scan [0..31], same delay setting for all data lines (“negative” delay value on the plot)
  - One scan [1..31] over clock delay (“positive” delay value on the plot)
  - Cycle through all 55 patterns
  - Record bit errors per delay setting, per data bit

**Pattern 20** (switching out of phase of bit 18)

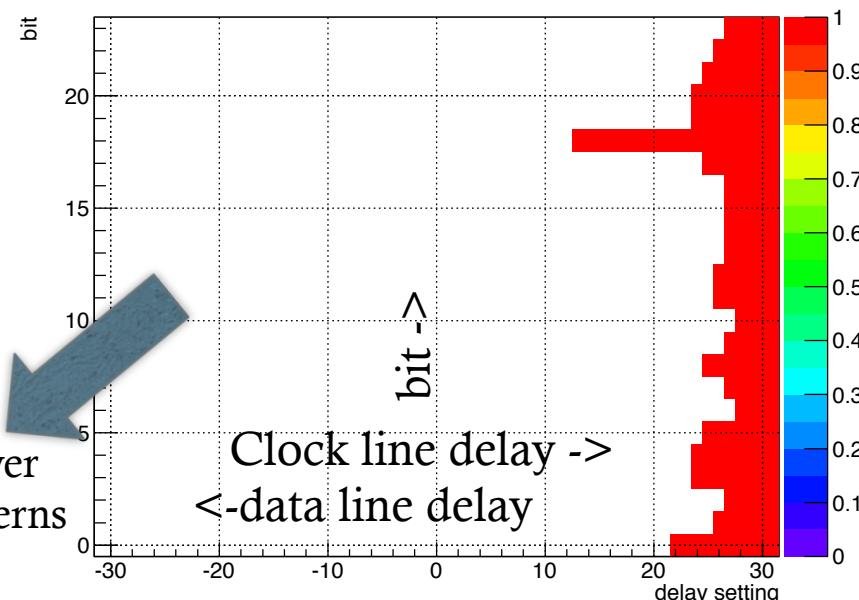
**CMX 0** (left side of crate)

**Channel 15**

Errors are just flagged, not counted!



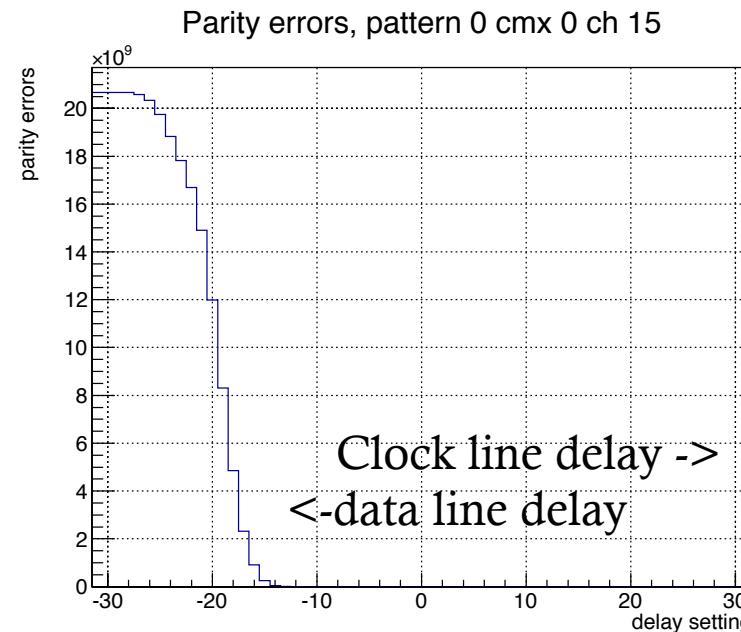
Data errors, pattern 20 cmx 0 ch 15



# Timing scans with random data

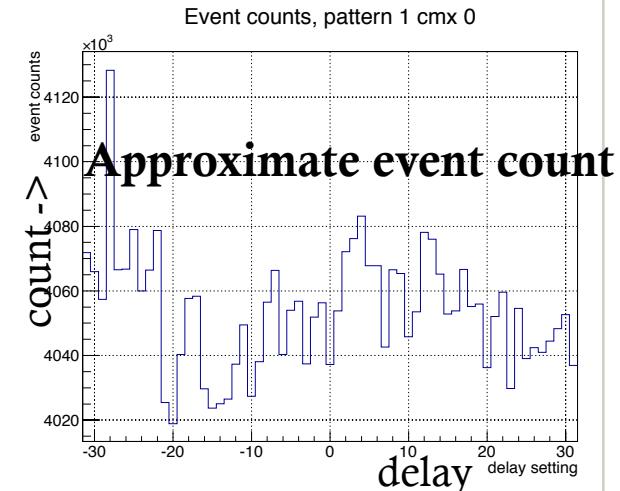
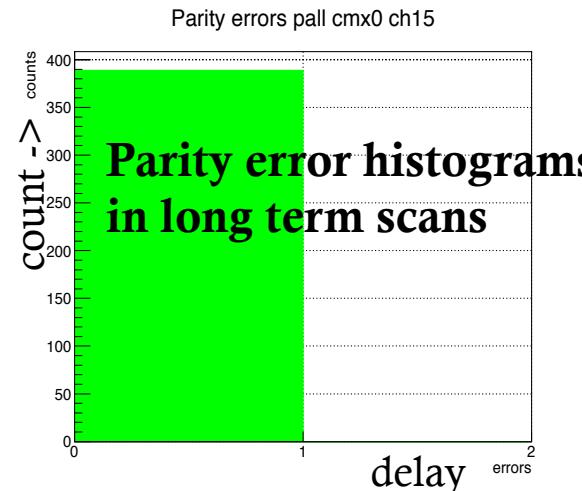
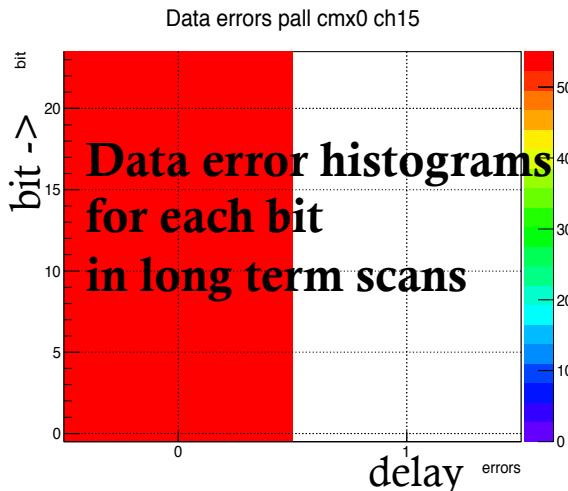
- Scan over delays on the data lines and clock lines using pseudo-random data
  - One scan [0..31], same delay setting for all data lines (“negative” delay value on the plot)
  - One scan [1..31] over clock delay (“positive” delay value on the plot)
  - Record parity errors per delay setting, per channel

**Pseudo random pattern**  
(different firmware on JEM)  
**CMX 0** (left side of crate)  
**Channel 15**  
Parity error counters do not exceed total event counts

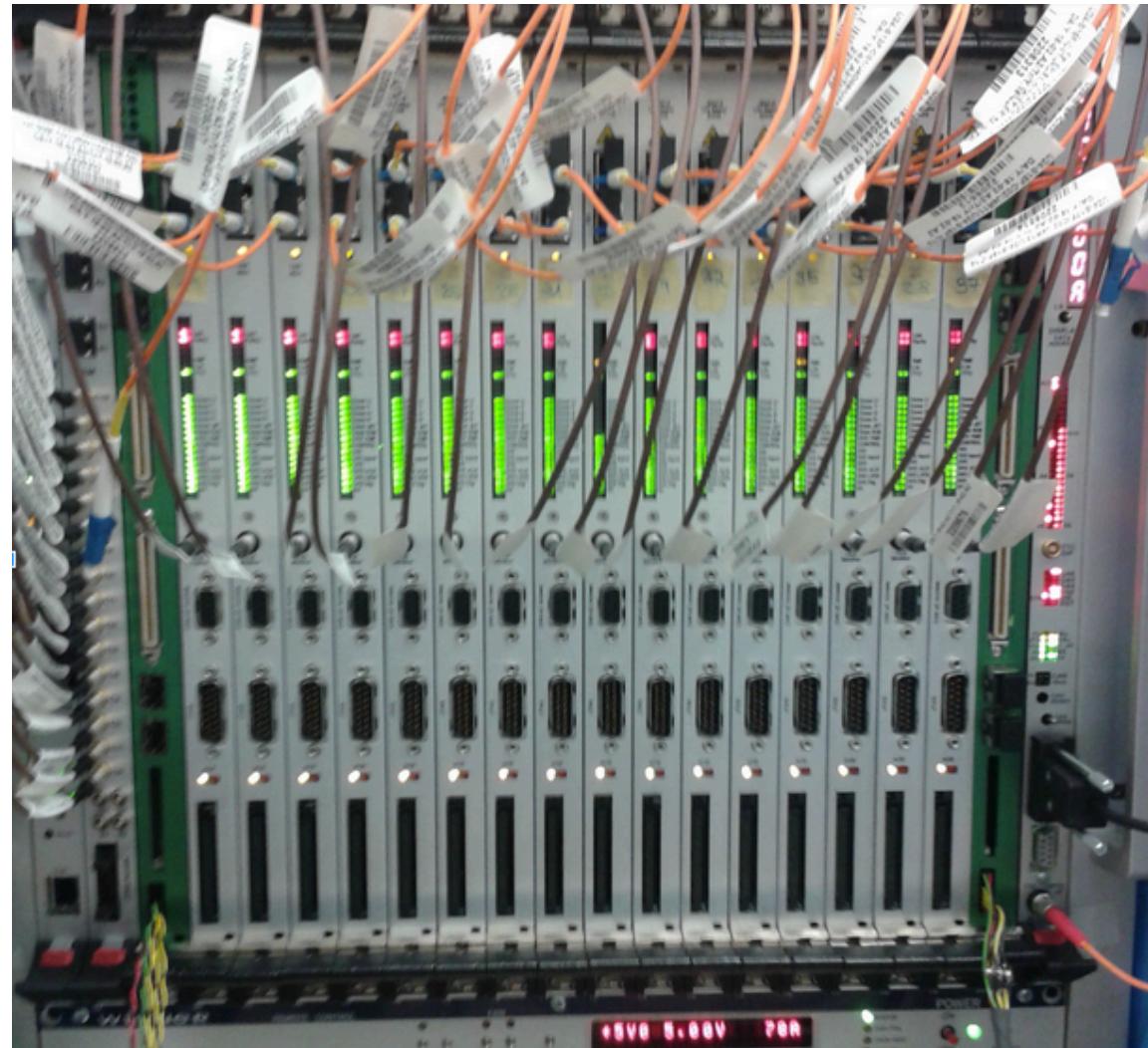


# Test procedures

- **Timing scans with patterns and pseudo-random data**
  - Test data integrity: find error free delay settings
  - Test data stability: determine the width of the error free range, determine roughly the center for long term tests
- **Long term tests with patterns and pseudo-random data**
  - Using center of the timing window
  - Determine limit on bit error ratio as  $1/( \text{dwell time} * 160 \text{ Mbps})$
  - Maximum run time  $\sim 100\text{s}$ , for longer tests need cycles of tests with regular readout of data and reset of counters



# Timing scans USA15



JEP0 crate

# Full crate tests JEMs

- Full crate tests in JEP0 crate with 16 JEMs

NO	run	CMX	time [s]	cycles	patterns	delay	total time [h]
1	1395868943	0/1	0.1	1	all patterns	scan	0.10
2	1396273108	0/1	0.1	1	all patterns	scan	0.10
3	1396277853	0/1	0.1	1	all patterns	scan	0.10
4	1396279431	0/1	5.0	1	all patterns	scan	4.81
5	1396303792+	0/1	50.0	10	all patterns	0/0	7.64
6	1396010274+	0/1	50.0	11	random	scan	9.63
7	1396049227+	0/1	50.0	384	random	10/10	5.32
8	1396964926	0	0.1	1	all patterns	scan	0.10
9	1396970468	0	5.0	1	all patterns	scan	4.81

- CMX SN03 - CMX 0 position receives data from SumET FPGAs
- CMX SN01 - CMX 1 position receives data from Jet FPGAs
- All in JEP0 crate, except for run #8 and run #9, use JEP1 crate and CMX SN01 only in CMX 0 position



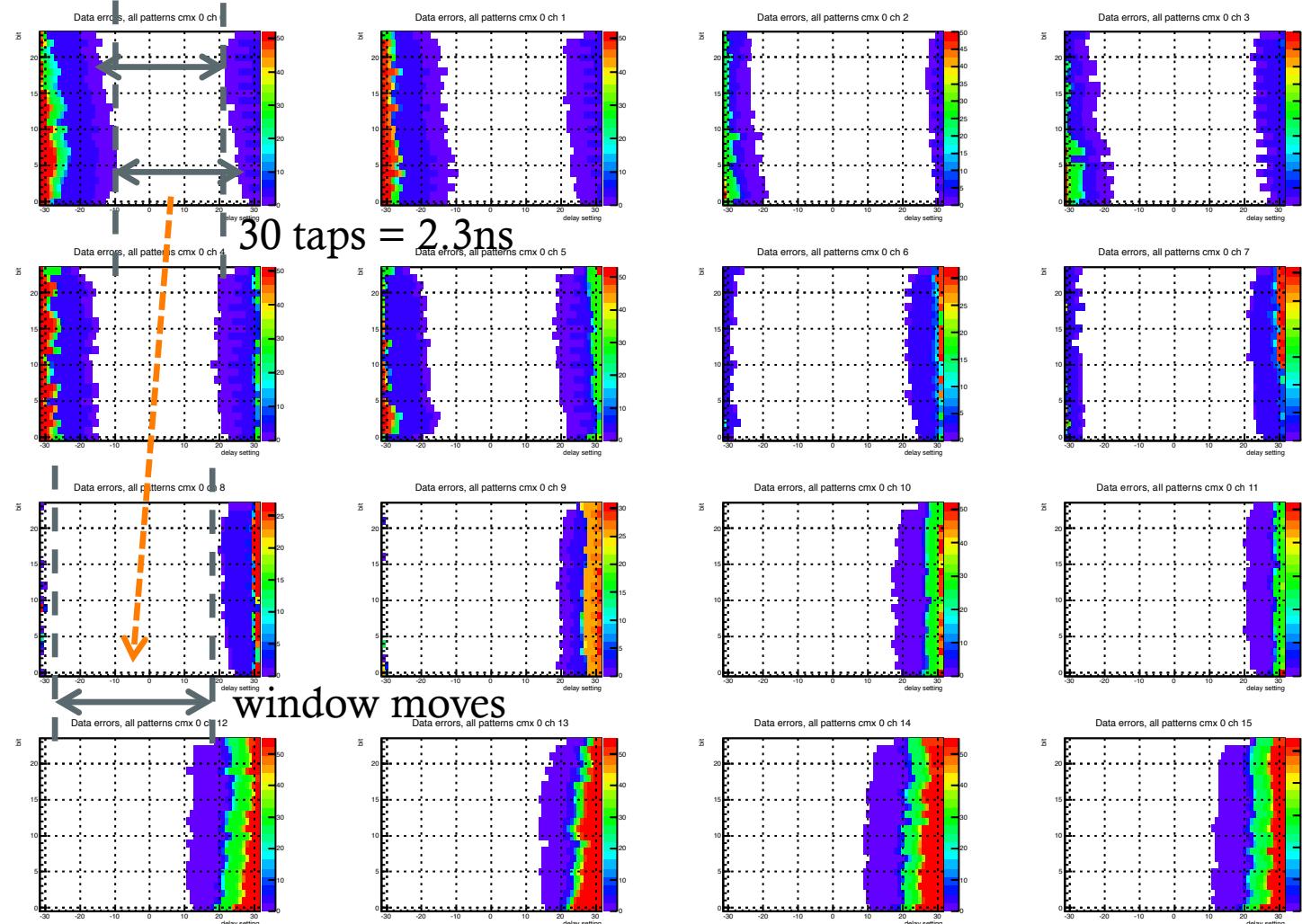
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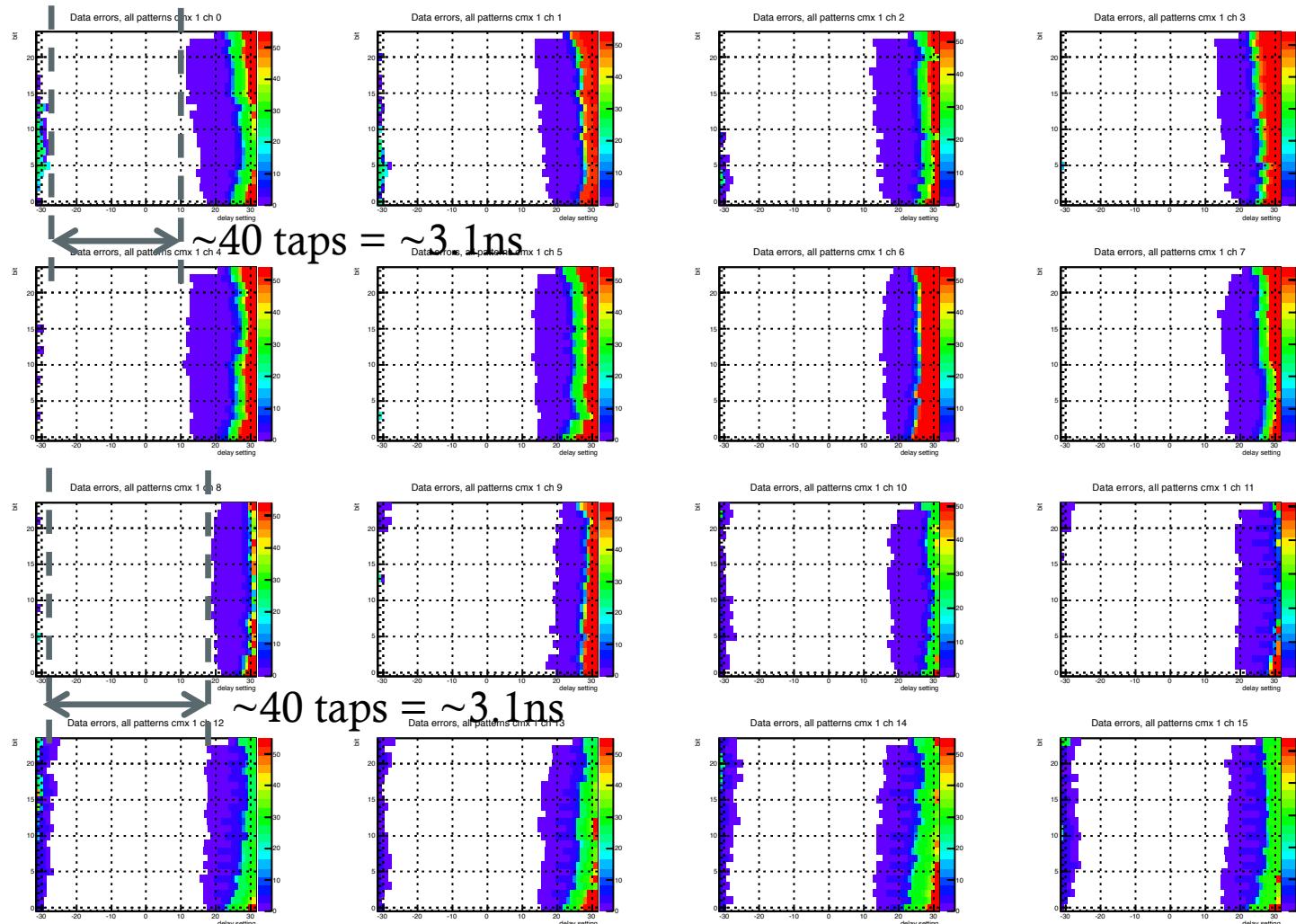
- Main results from run #4 to run #7
- For pattern and pseudo-random data different firmware configurations used, phase between data and clock possibly different, do not expect optimal delay settings to be the same

# Timing scan JEMs



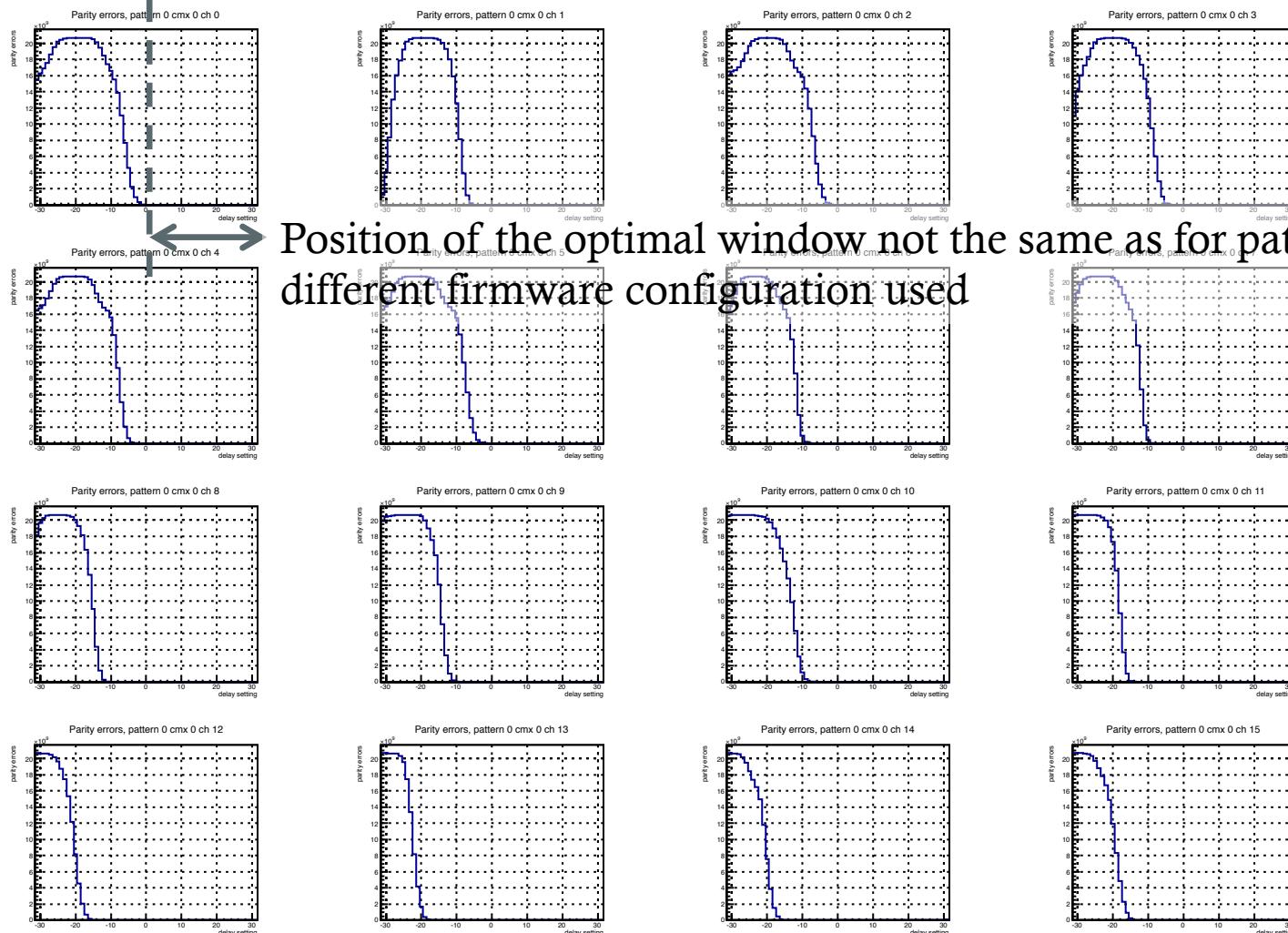
Run #4: CMX0, all patterns, 5s dwell time per scan point

# Timing scan JEMs



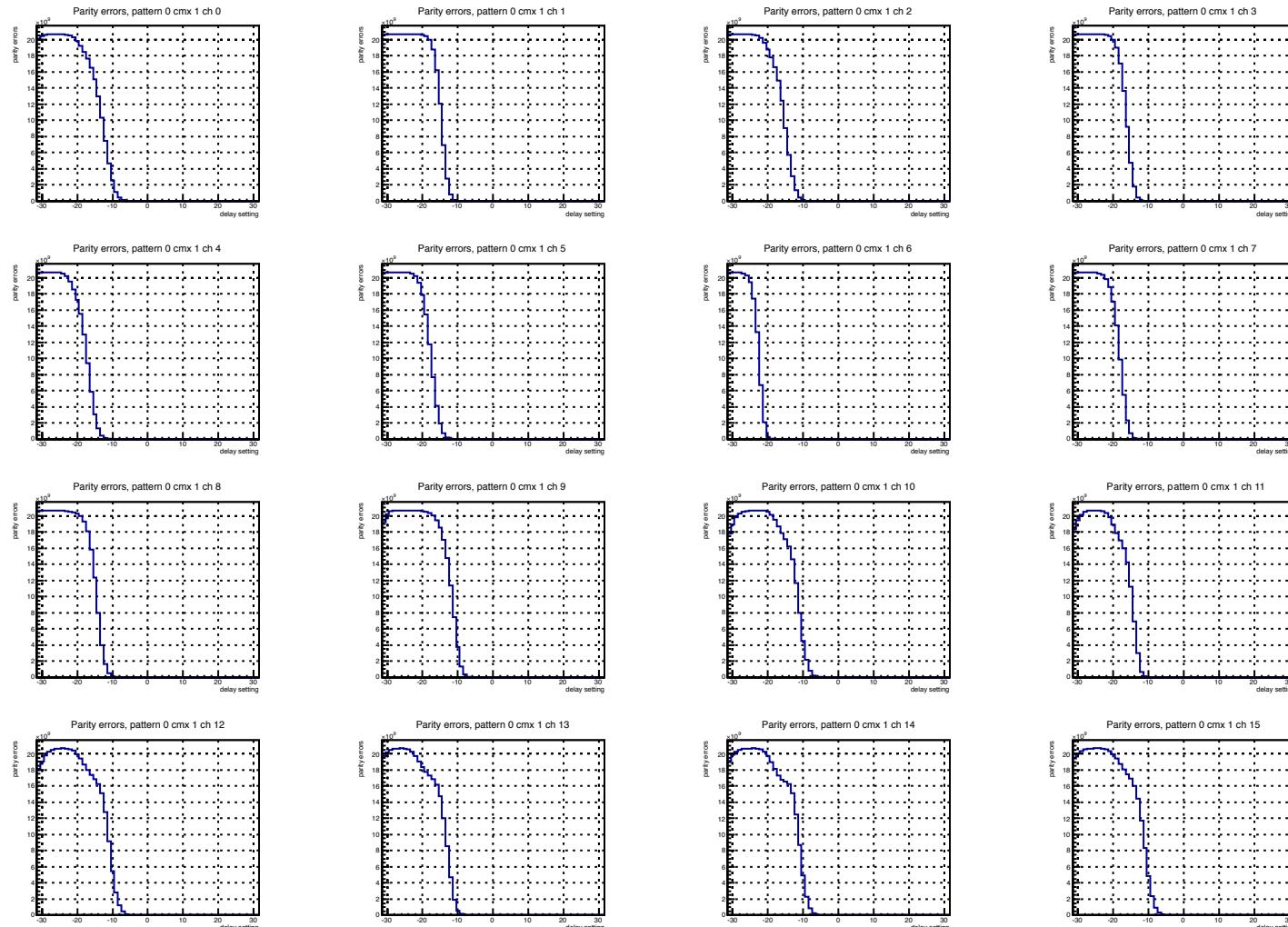
Run #4: CMX1, all patterns, 5s dwell time per scan point

# Timing scan JEMs



Run #6: CMX0, pseudo-random data, 50s dwell time per scan point

# Timing scan JEMs



Run #6: CMX1, pseudo-random data, 50s dwell time per scan point

# Full crate tests JEMs

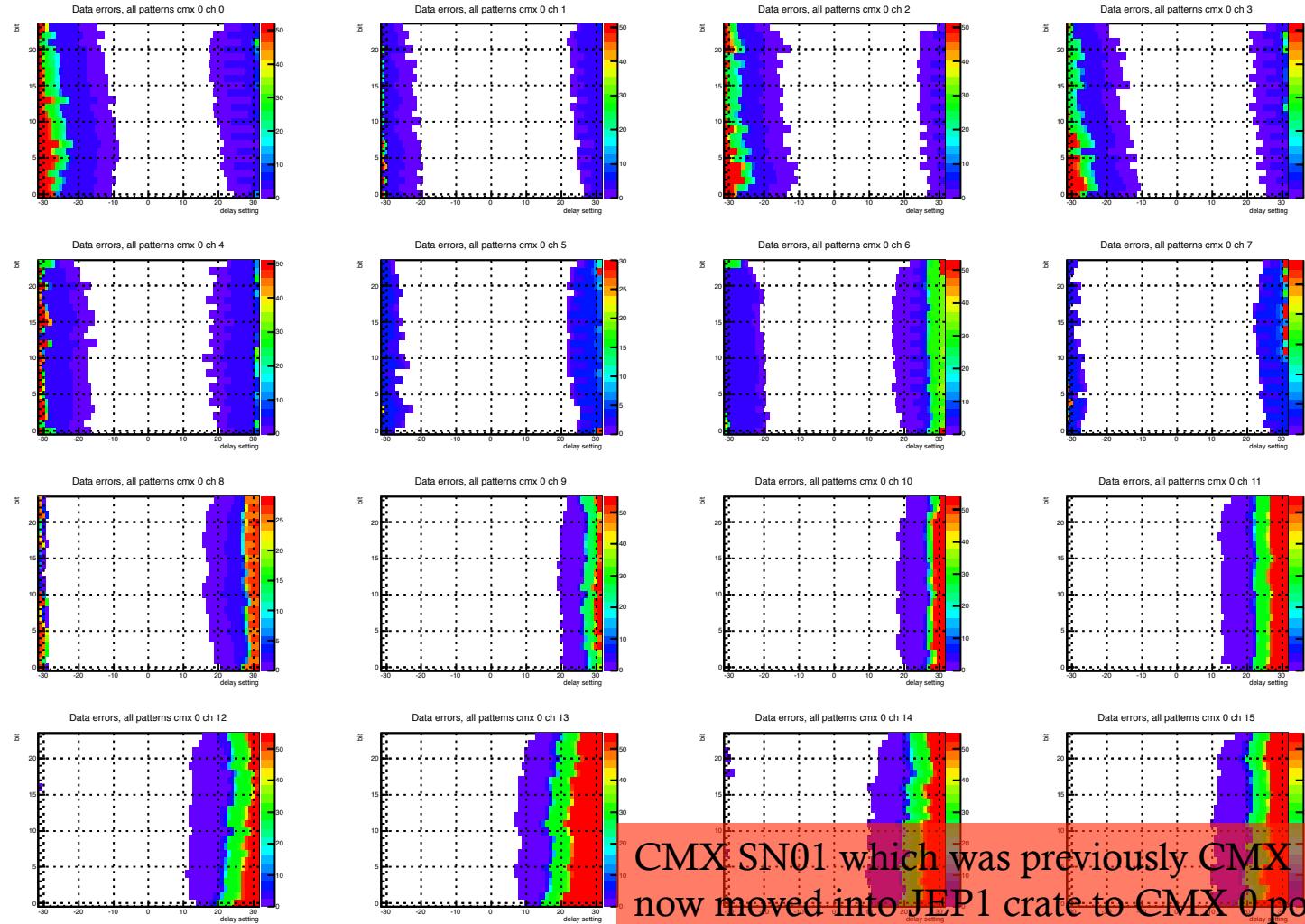
- Full crate tests in JEP0 crate with 16 JEMs

NO	run	CMX	time [s]	cycles	patterns	delay	total time [h]
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8	1396964926	0	0.1	1	all patterns	scan	0.10
9	1396970468	0	5.0	1	all patterns	scan	4.81

- Run #8 and run #9
  - corrected pattern 25 to probe bit 23 in the intended way
  - CMX SN01 from CMX 1 moved to CMX 0 position in JEP1 crate
  - only one CMX, but no difference to other runs or problems uncovered
  - Systematic shift of the window still visible for CMX 0 position



# Post-tests timing scans JEMs



Run #9: CMX0, all patterns, 5s dwell time per scan point

# Full crate tests JEMs

- **Comfortable window of at least ~2.3ns and ~3.1ns**
  - Window on CMX 0 position moves systematically from module to module
  - Difference in window sizes on CMX 0 and CMX 1 (related to the position, not to the module)
  - In tests with pseudo-random data the other edge cannot be probed
- **No power or heat issues**
- **Longest runs with 0/0 delay settings for 7.6h and all patterns**
  - Limit on bit error ratio is  $23 \times 10^{-14}$ , would translate into event error rate of 0.09 Hz (assuming one bit in any of the 400 data lines and 6 CMX will trigger an event)

# Full crate tests CPMs

- Full crate tests in CP0 crate with 14 CPMs

NO	run	CMX	time [s]	cycles	patterns	delay	total time [h]
1	1396388038	0/1	5.0	1	all patterns	scan	4.81
2	1396406084+	0/1	50.0	8	all patterns	-10/-10	6.11
3	1396625660	0/1	0.1	1	all patterns	scan	0.10
4	1396629697	0/1	5.0	1	all patterns	scan	4.81
5	1396650911+	0/1	50.0	23	all patterns	-10/-10	17.57
6	1396647710	0/1	50.0	1	random	scan	0.88
7	1396716630+	0/1	50.0	1265	random	-10/-10	17.57
8	1396949335+	0	85.0	1	random	scan	1.49

- CMX SN03 - CMX 0 position
- CMX SN01 - CMX 1 position
- All in CP0 crate, removed CMX SN01 in run #8 to be placed into JEP1 crate

# Full crate tests CPMs

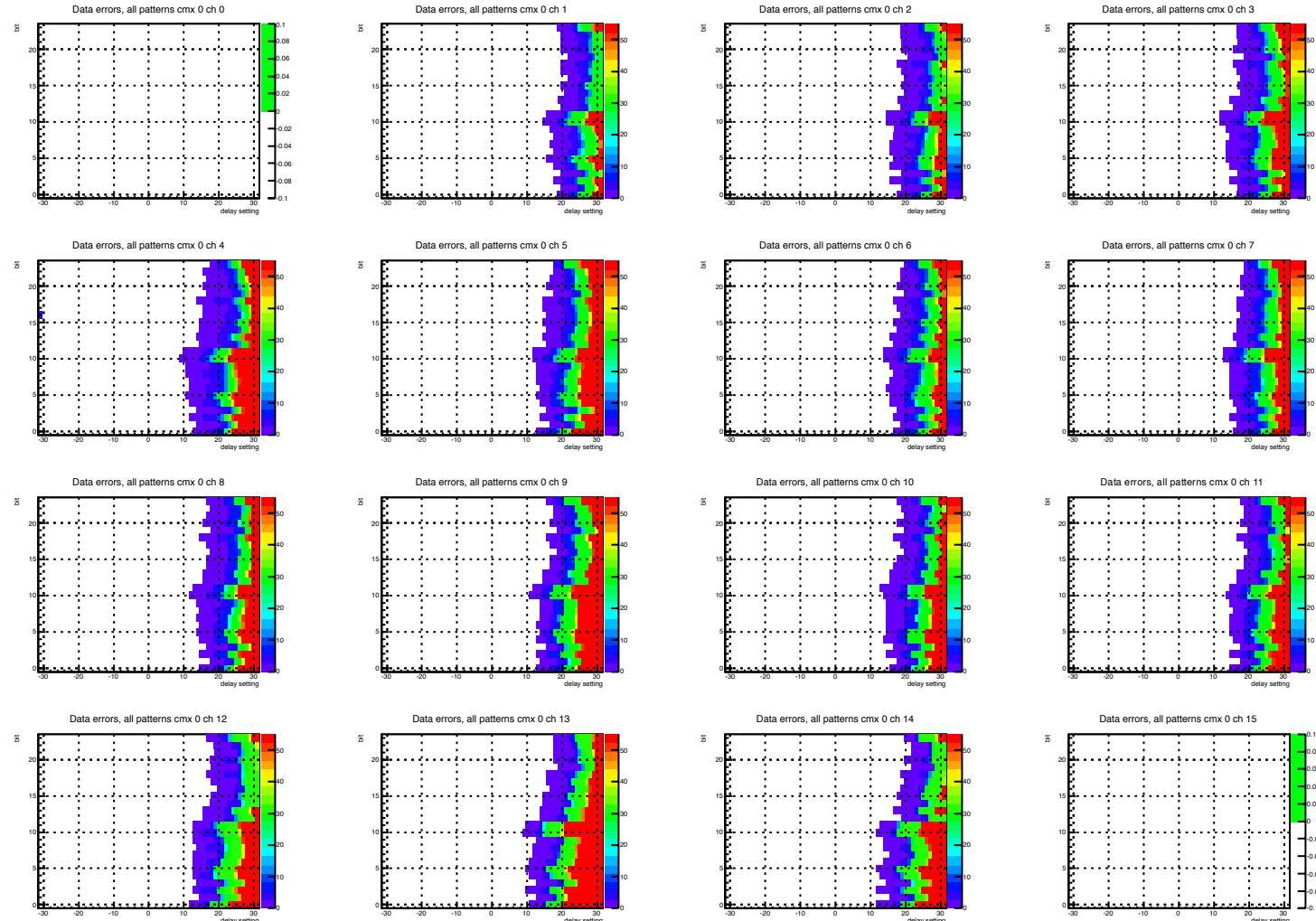
- Full crate tests in CP0 crate with 14 CPMs

NO	run	CMX	time [s]	cycles	patterns	delay	total time [h]
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6	1396647710	0/1	50.0	1	random	scan	0.88
7	1396716630+	0/1	50.0	1265	random	-10/-10	17.57
8	1396949335+	0	85.0	1	random	scan	1.49

- Main results from run #4 to run #7, for BER scan time from run #2 and run #5 were added

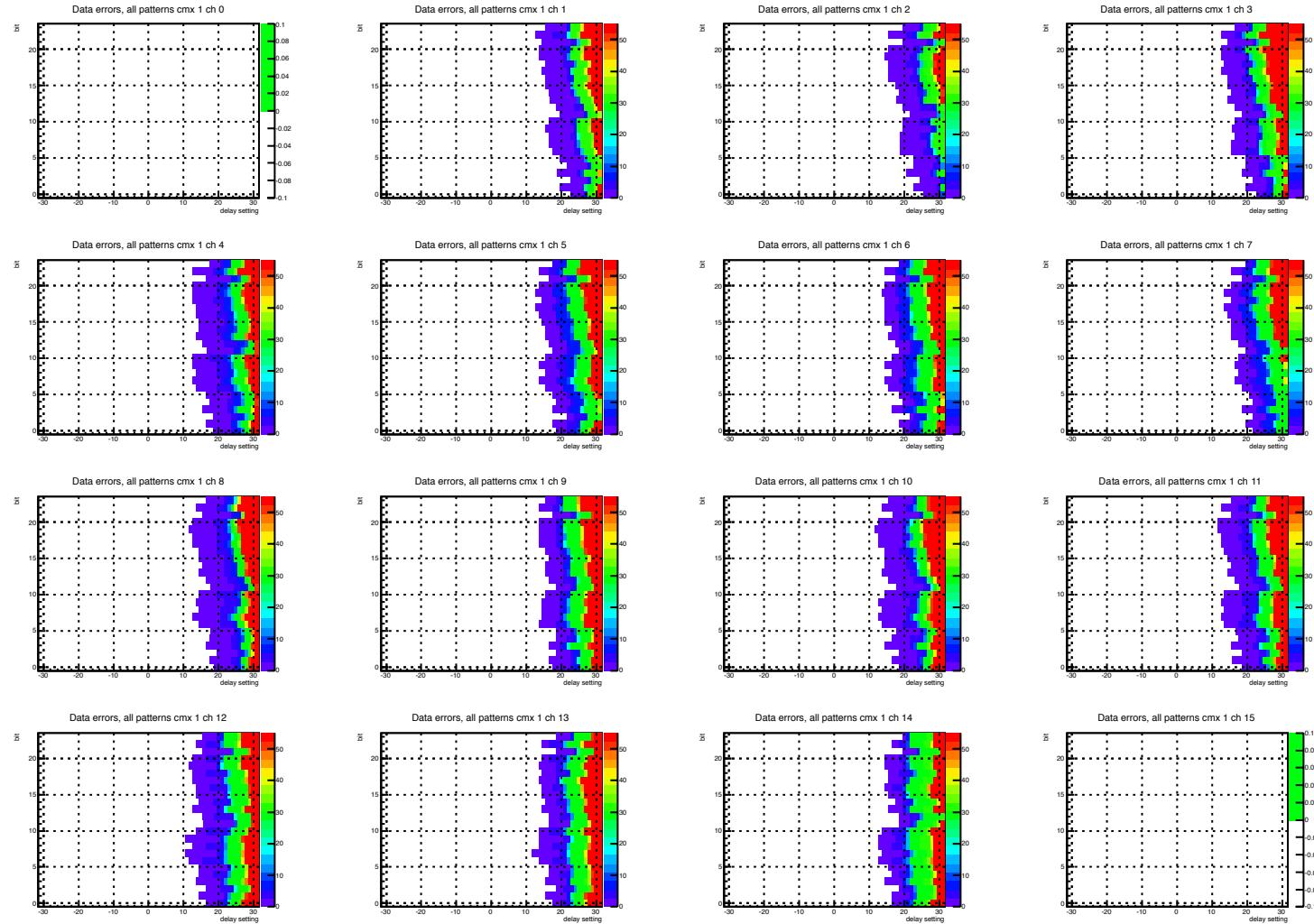


# Timing scan CPMs



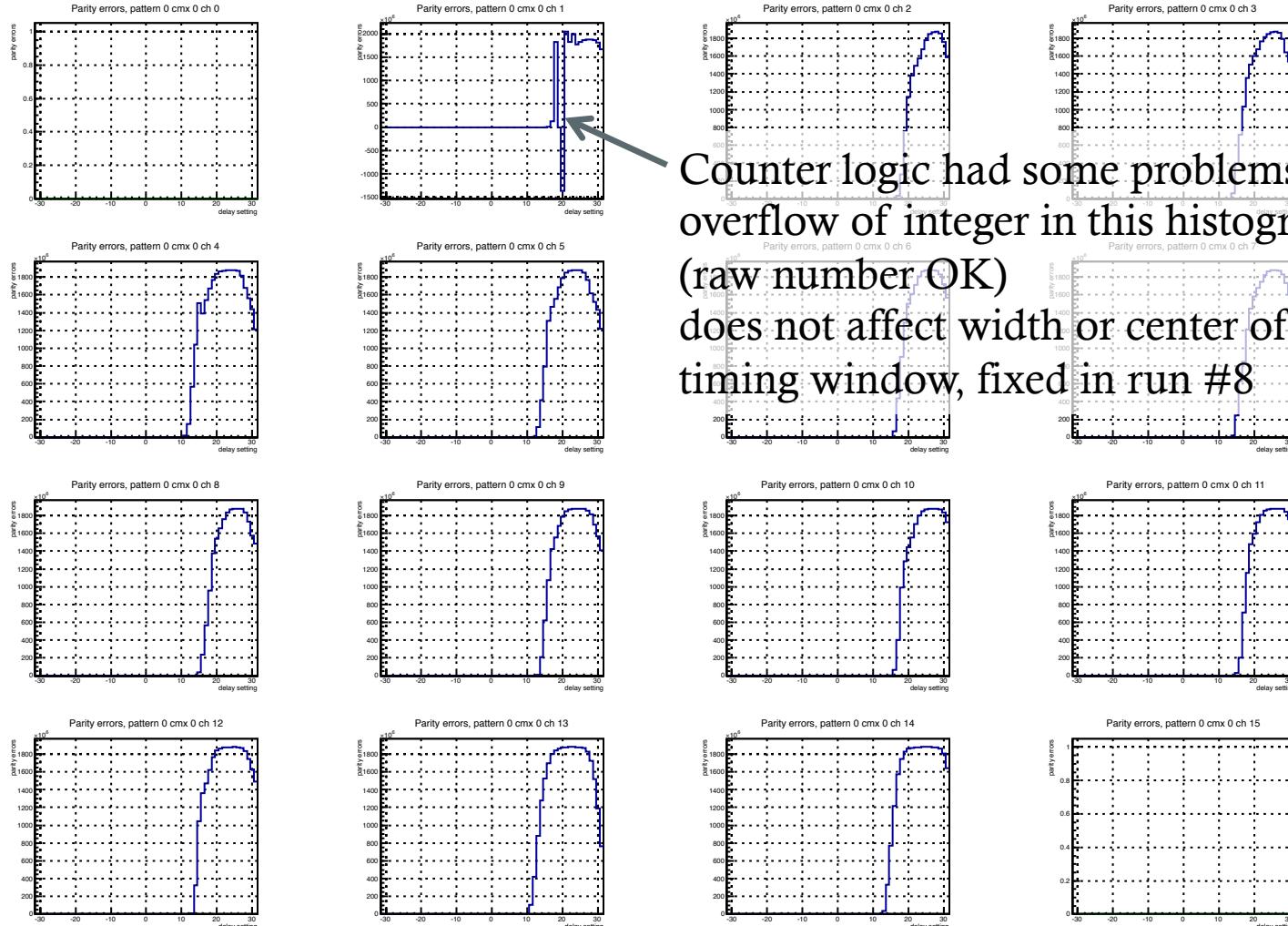
Run #4: CMX0, all patterns, 5s dwell time per scan point

# Timing scan CPMs



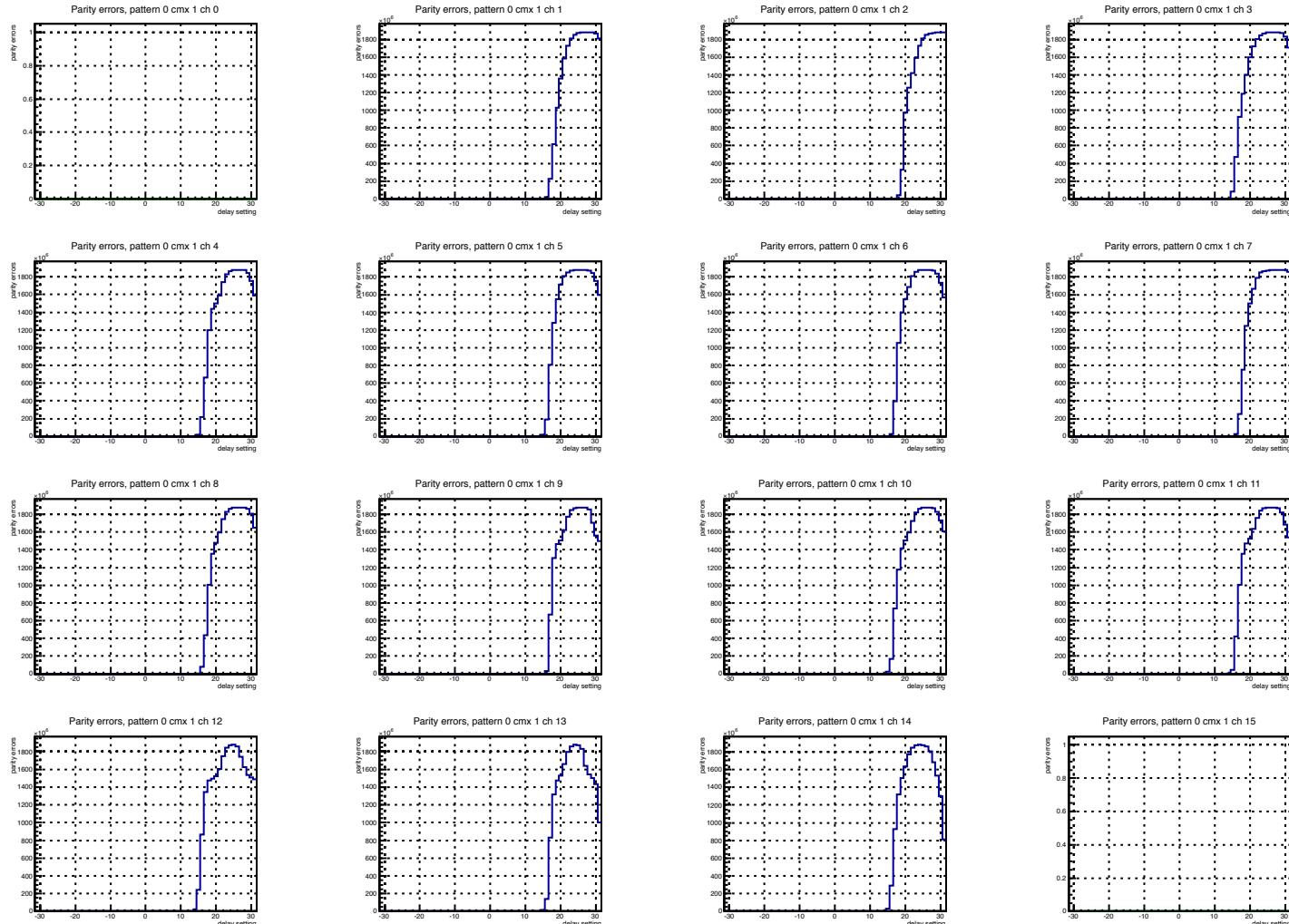
Run #4: CMX1, all patterns, 5s dwell time per scan point

# Timing scan CPMs



Run #6: CMX0, pseudo-random data, 50s dwell time per scan point

# Timing scan CPMs



Run #6: CMX1, pseudo-random data, 50s dwell time per scan point

# Full crate tests CPMs

- **Comfortable window of at least ~3.1ns**
  - More homogenous timing window width and position
  - In all tests the other edge cannot be probed
- **No power or heat issues**
- **Longest runs with -10/-10 delay settings for 23.7h and all patterns**
  - Limit on bit error ratio is  $7.3 \times 10^{-14}$ , would translate into event error rate of 0.03 Hz (assuming one bit in any of the 400 data lines and 6 CMX will trigger an event)



# Conclusions

- Operation of both CMX prototypes in full crates of JEMs/CPMs in USA15
- Results indicate good data integrity, wide good timing window for data capture and stable data reception over hours
  - Limit on event error rate seems to be sufficient for L1 trigger requirement
  - A few not well understood features of the variation in the position and width of the timing window
  - None indicate problems with the CMX backplane itself
  - Timing scan procedure will be develop into a timing calibration procedure



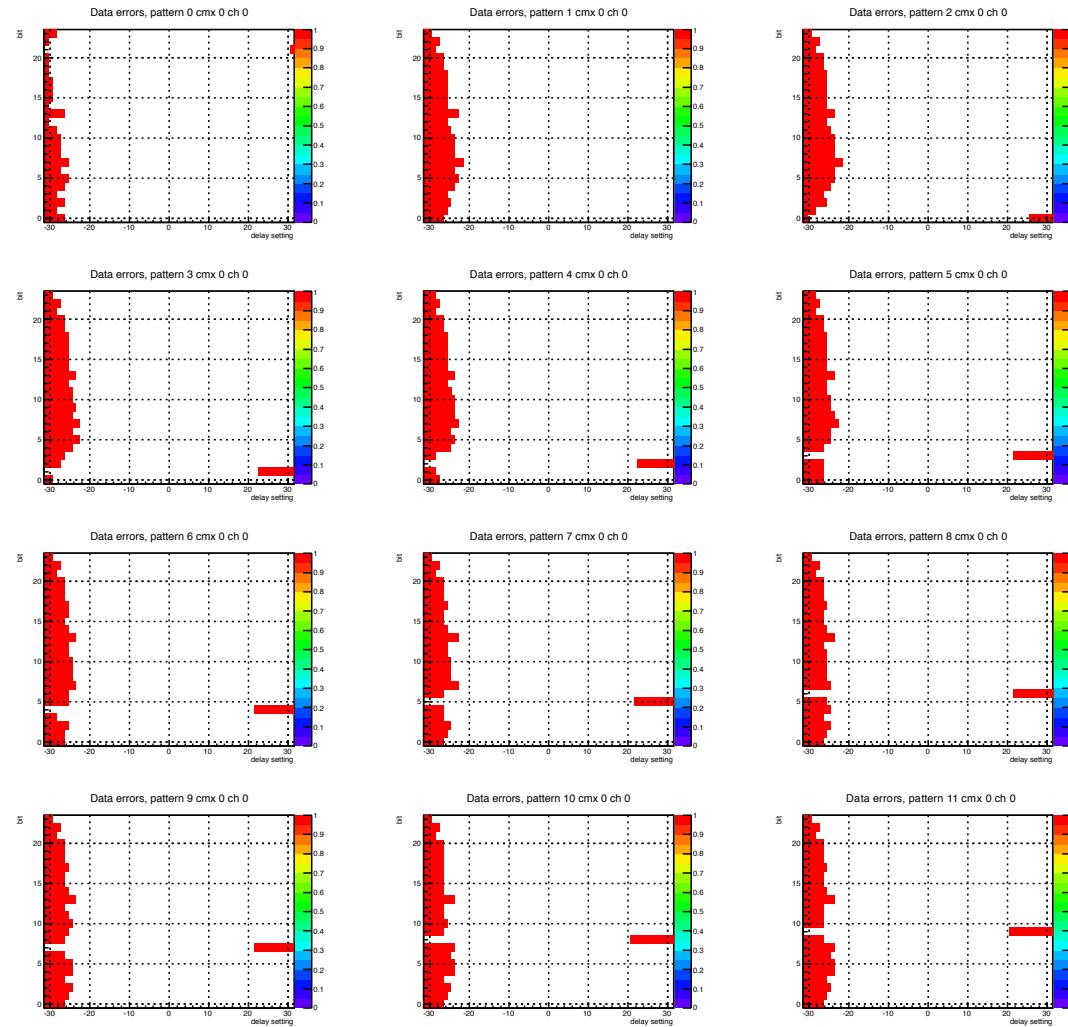


# Test procedures

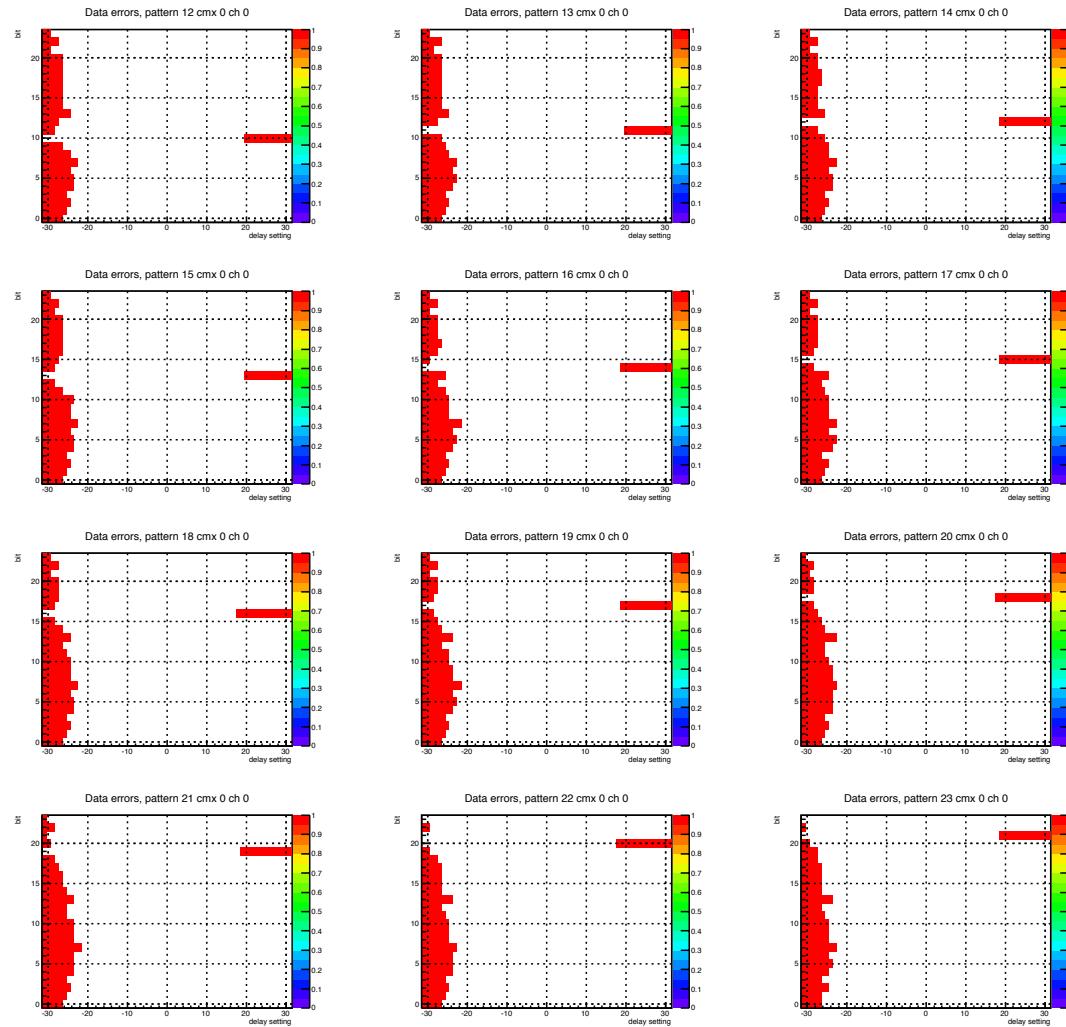
- **Test backplane data transmission fidelity at 160 Mbps/signal**
  - Data integrity: no shorts, no opens
  - Data stability: Good timing window (bathtub curve) wide enough to guarantee stable operation, flexibility to cope with different/problematic timing configurations
  - Long term data stability: long term test, determination of bit error ratio and event error ratio/rate
- **Tests using data patterns and pseudo-random data, either timing scan over data/clock delays or fix timing for long term tests**
  - Patterns designed to stress data lines, do not correspond to physics data



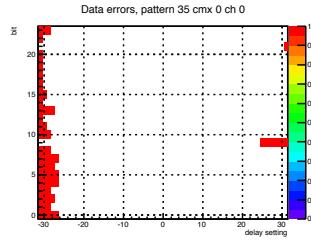
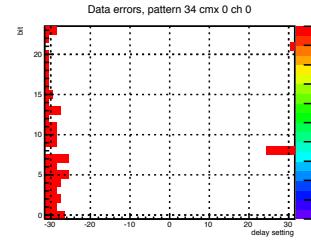
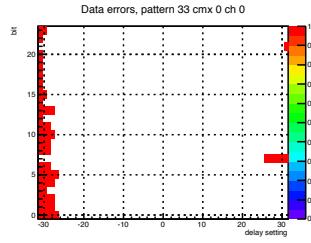
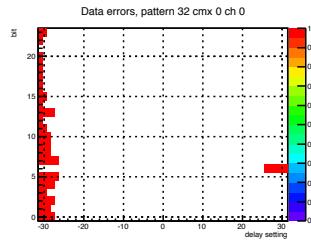
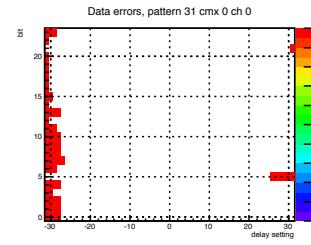
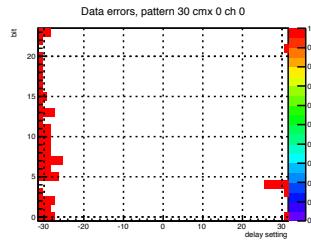
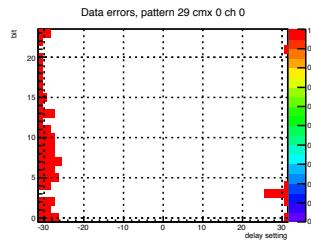
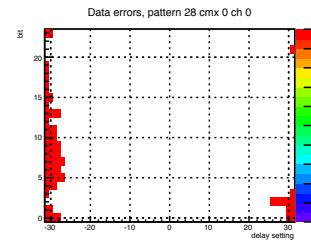
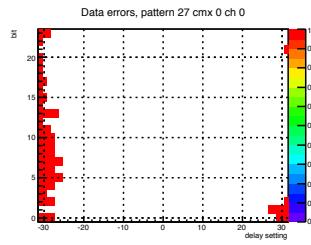
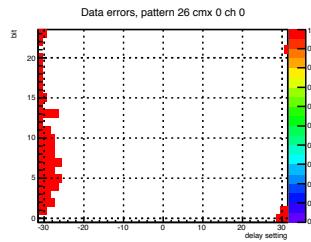
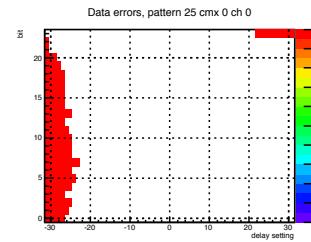
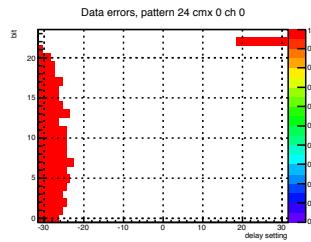
# Timing scans with patterns



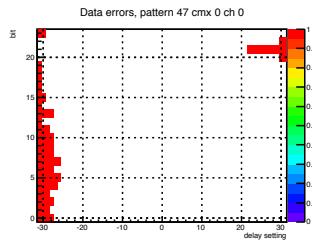
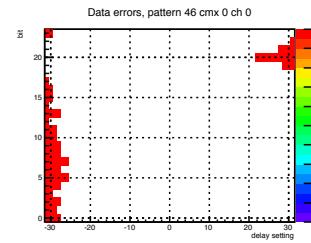
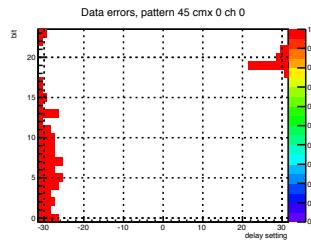
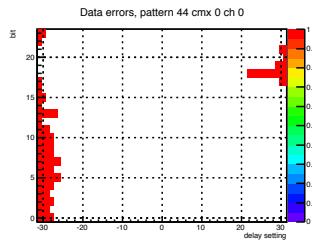
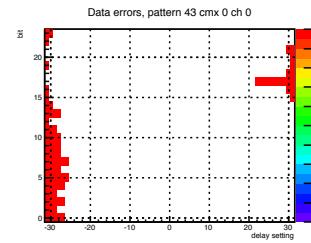
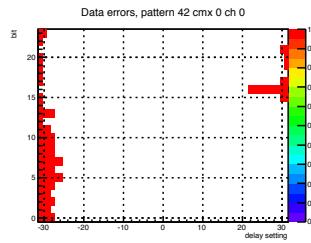
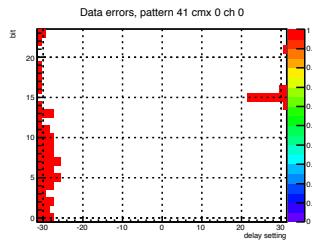
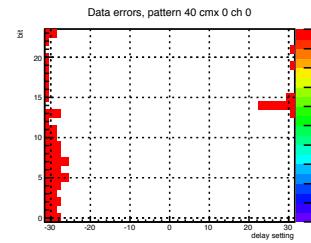
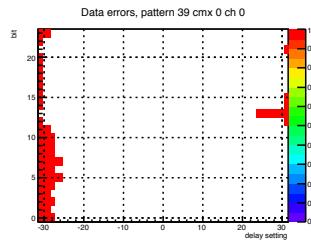
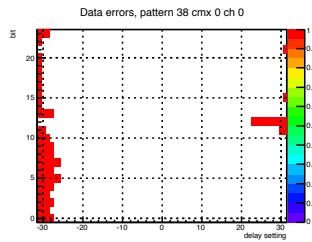
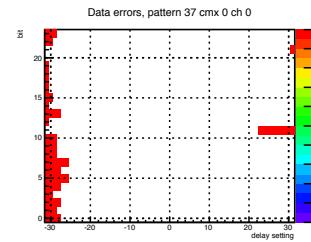
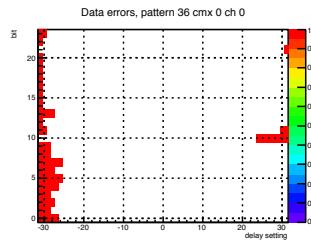
# Timing scans with patterns



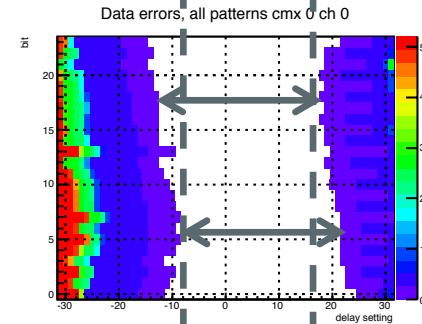
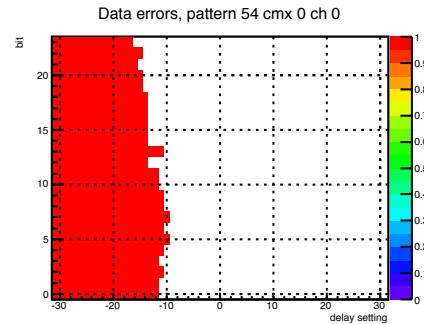
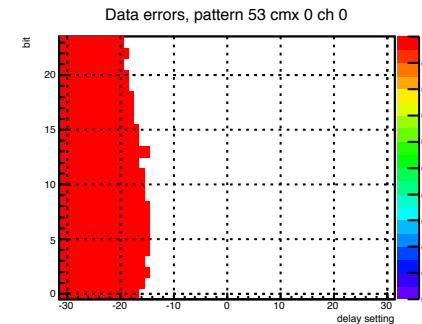
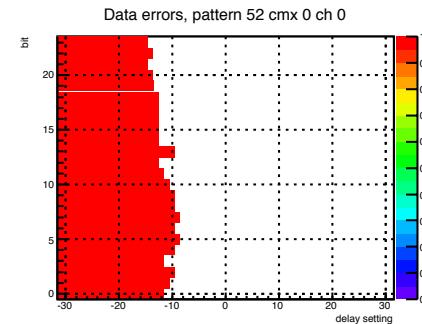
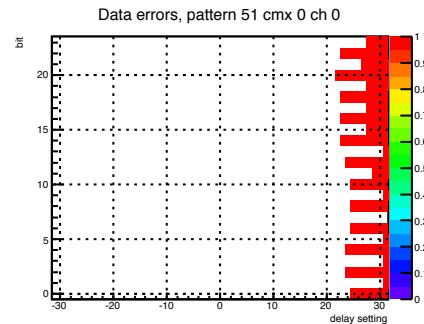
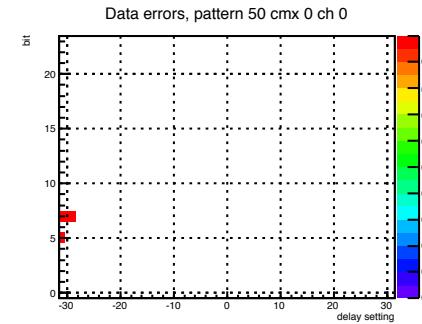
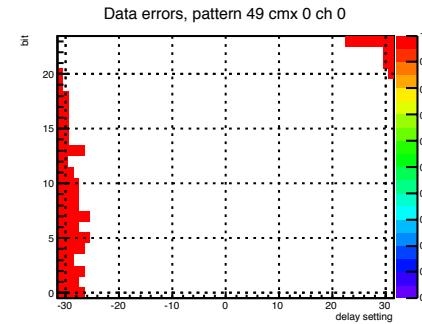
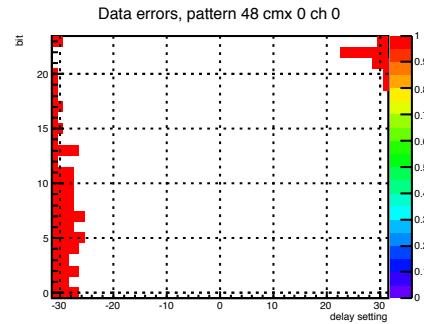
# Timing scans with patterns



# Timing scans with patterns



# Timing scans with patterns



Sum over all patterns

Timing window width

# Full crate tests JEMs

- Full crate tests in JEP0 crate with 16 JEMs

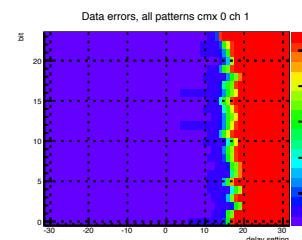
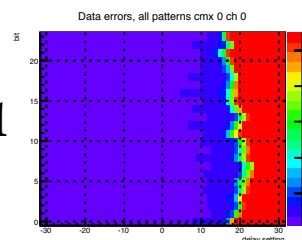
NO	run	CMX	time [s]	cycles	patterns	delay	total time [h]
1	1395868943	0/1	0.1	1	all patterns	scan	0.10
2	1396273108	0/1	0.1	1	all patterns	scan	0.10
3	1396277853	0/1	0.1	1	all patterns	scan	0.10
4	1396279431	0/1	5.0	1	all patterns	scan	4.81
5	1396303792+	0/1	50.0	10	all patterns	0/0	7.64
6	1396010274+	0/1	50.0	11	random	scan	9.63
7	1396049227+	0/1	50.0	384	random	10/10	5.32
8	1396964926	0	0.1	1	all patterns	scan	0.10
9	1396970468	0	5.0	1	all patterns	scan	4.81

- Run #1: patterns 22, 25, 54 mismatch in firmware and CMX spy memory, default timing setting in JEM FPGAs (clock edges shifted by 3.125 ns with respect to data edge)
- Run #2: clock shift removed on SumET FPGA
- Run #3: clock shift moved to 1.5ns
- Were able to move the center of the window around delay setting 0

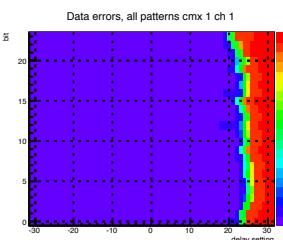
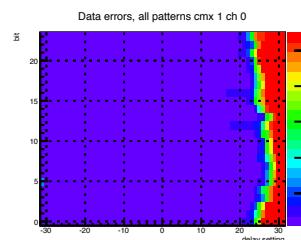


# Pre-tests timing scans JEMs

Run #1

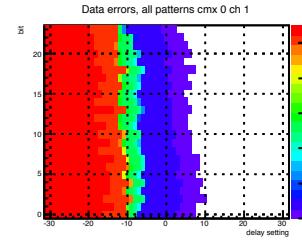
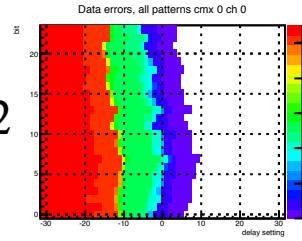


CMX 1

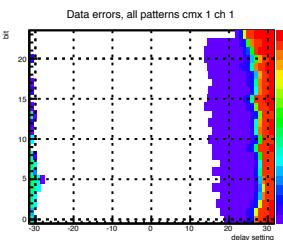
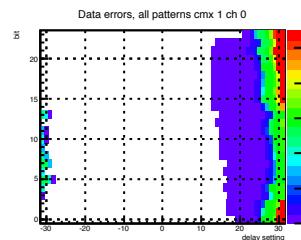


clock | data 3.125ns

Run #2

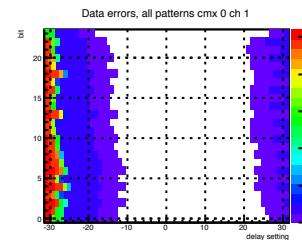
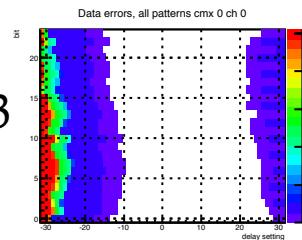


clock | data 0ns

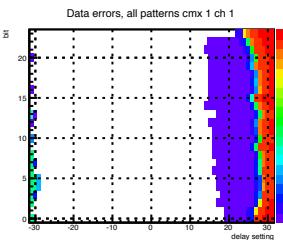
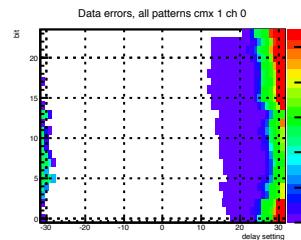


clock | data 1.5ns

Run #3



clock | data 1.5ns



clock | data 1.5ns

*In all histograms: channels 0 and 1*

# Full crate tests CPMs

- Full crate tests in CP0 crate with 14 CPMs

NO	run	CMX	time [s]	cycles	patterns	delay	total time [h]
1	1396388038	0/1	5.0	1	all patterns	scan	4.81
2	1396406084+	0/1	50.0	8	all patterns	-10/-10	6.11
3	1396625660	0/1	0.1	1	all patterns	scan	0.10
4	1396629697	0/1	5.0	1	all patterns	scan	4.81
5	1396650911+	0/1	50.0	23	all patterns	-10/-10	17.57
6	1396647710	0/1	50.0	1	random	scan	0.88
7	1396716630+	0/1	50.0	1265	random	-10/-10	17.57
8	1396949335+	0	85.0	1	random	scan	1.49

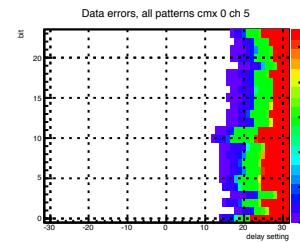
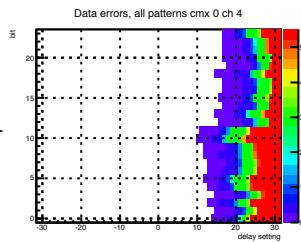
- Run #1 and run #2: unsynchronized pattern start on CPMs (no BC reset reception in firmware possible), compensated with shifted patterns stored in CMX spy memory
- Run #3: synchronized pattern start on CPMs, no difference seen in results



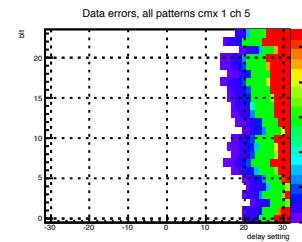
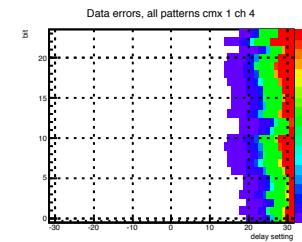
# Pretests timing scans CPMs

Run #1

CMX 0

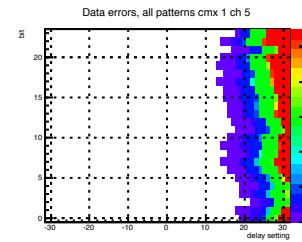
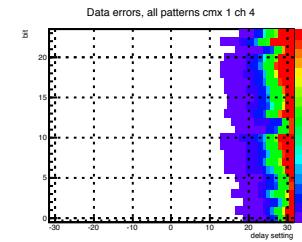
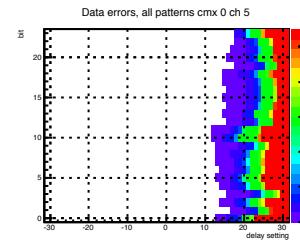
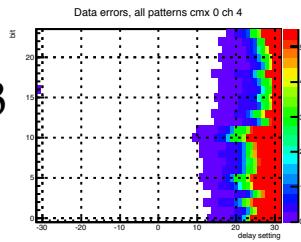


CMX 1



Unsynchronised patterns

Run #3



Synchronised patterns

*In all histograms: channels 4 and 5*



# Full crate tests CPMs

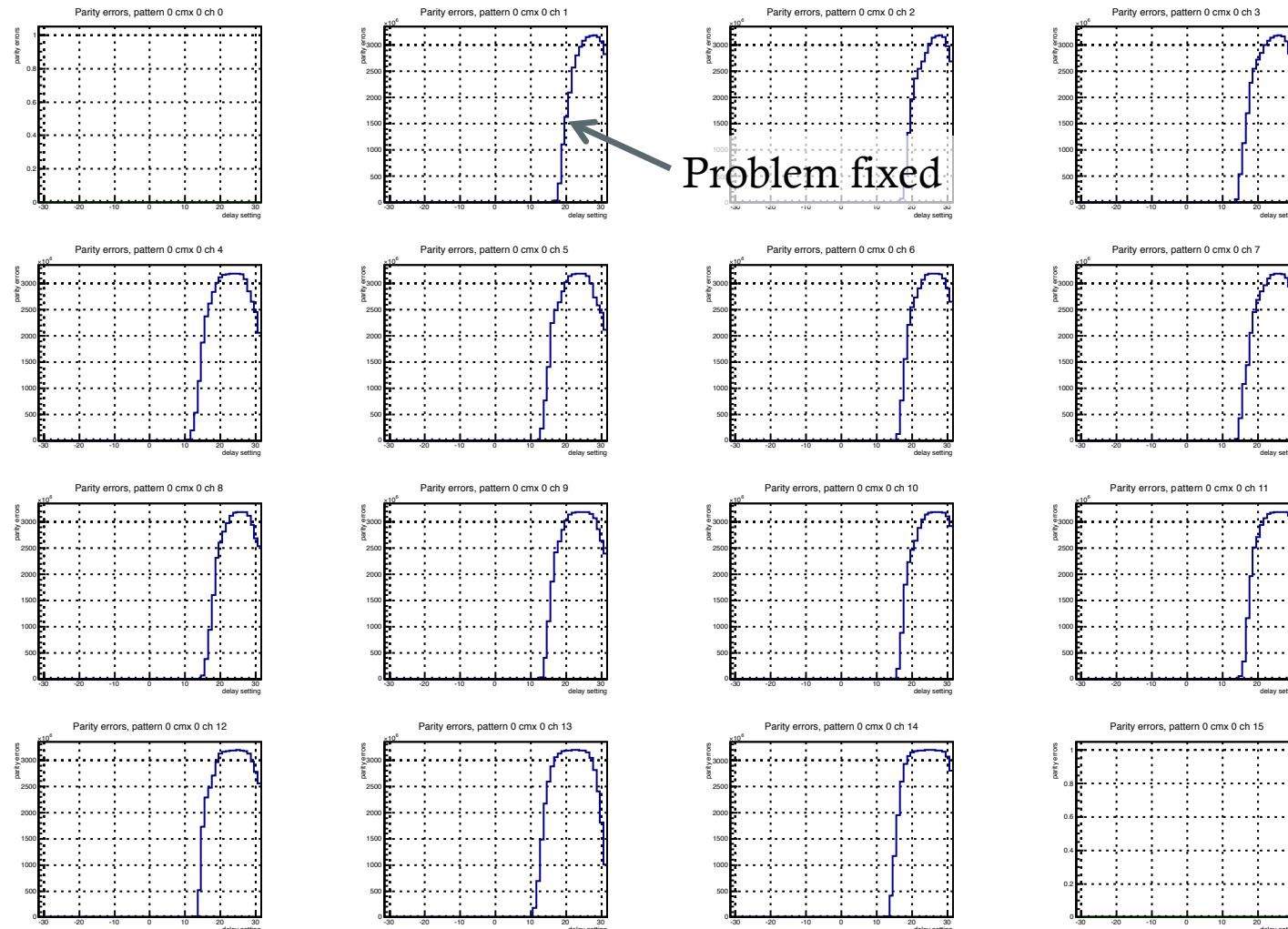
- Full crate tests in CP0 crate with 14 CPMs

NO	run	CMX	time [s]	cycles	patterns	delay	total time [h]
1	1396388038	0/1	5.0	1	all patterns	scan	4.81
2	1396406084+	0/1	50.0	8	all patterns	-10/-10	6.11
3	1396625660	0/1	0.1	1	all patterns	scan	0.10
4	1396629697	0/1	5.0	1	all patterns	scan	4.81
5	1396650911+	0/1	50.0	23	all patterns	-10/-10	17.57
6	1396647710	0/1	50.0	1	random	scan	0.88
7	1396716630+	0/1	50.0	1265	random	-10/-10	17.57
8	1396949335+	0	85.0	1	random	scan	1.49

- problems with error counting in meta stable timing region fixed
- feature understood: counts are almost 2x event counts, error checking with 80 MHz clock, counting with 40 MHz clock, double counting in meta stable region possible
- no influence on timing window width or position



# Post-test timing scan CPMs



Run #8: CMX0, pseudo-random data, 85s dwell time per scan point



- **Patterns 52-54**

**Pattern 52:**

0110 1010 1010 1010 1010 ...  
0110 1010 1010 1010 1010 ...  
0110 1010 1010 1010 1010 ...

*up to 24th bit...*

**Pattern 53:**

0110 0110 0110 0110 0110 ...  
0110 0110 0110 0110 0110 ...  
0110 0110 0110 0110 0110 ...

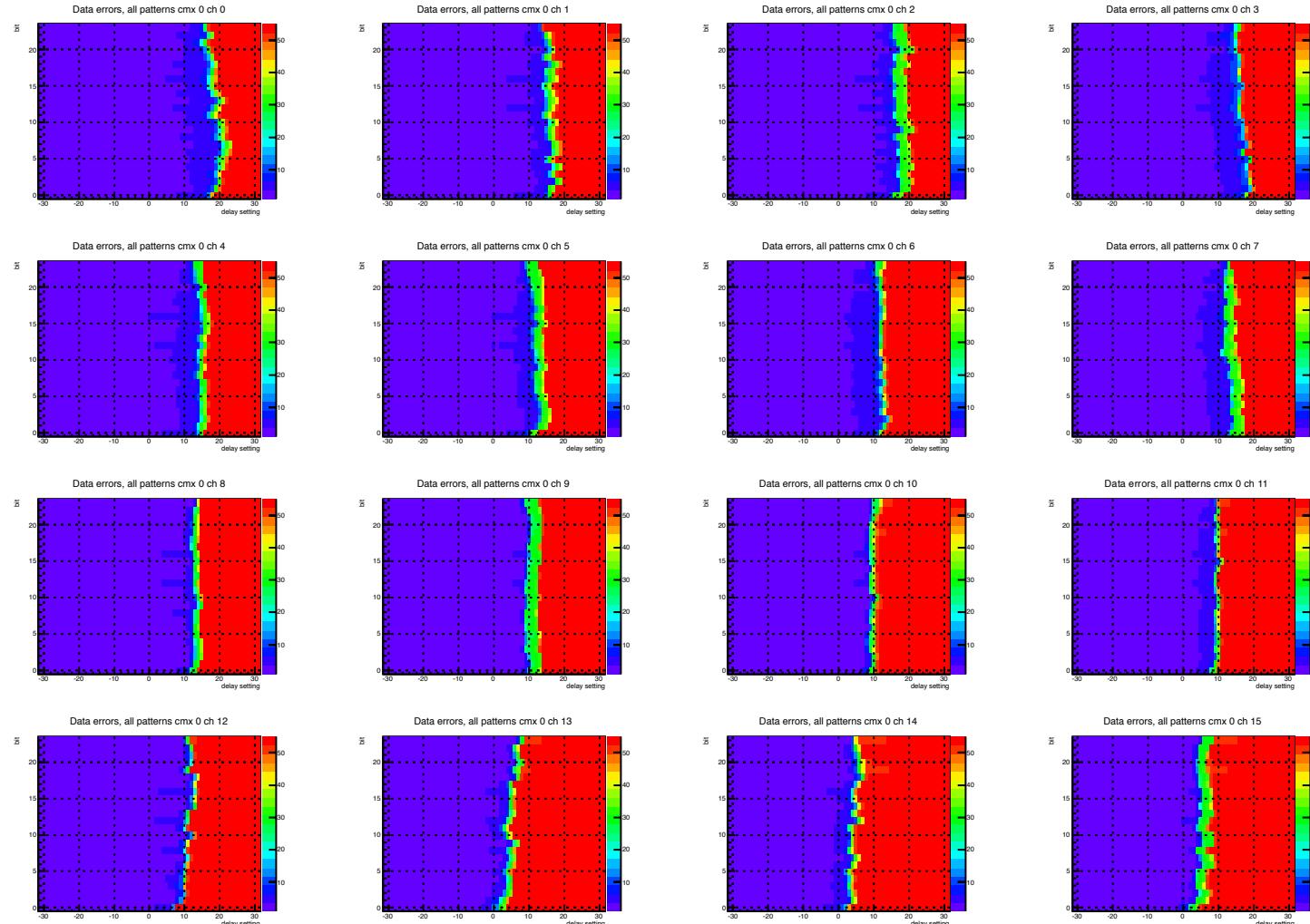
*up to 24th bit...*

**Pattern 54:**

1001 0110 0110 0110 0110 ...  
1001 0110 0110 0110 0110 ...  
1001 0110 0110 0110 0110 ...

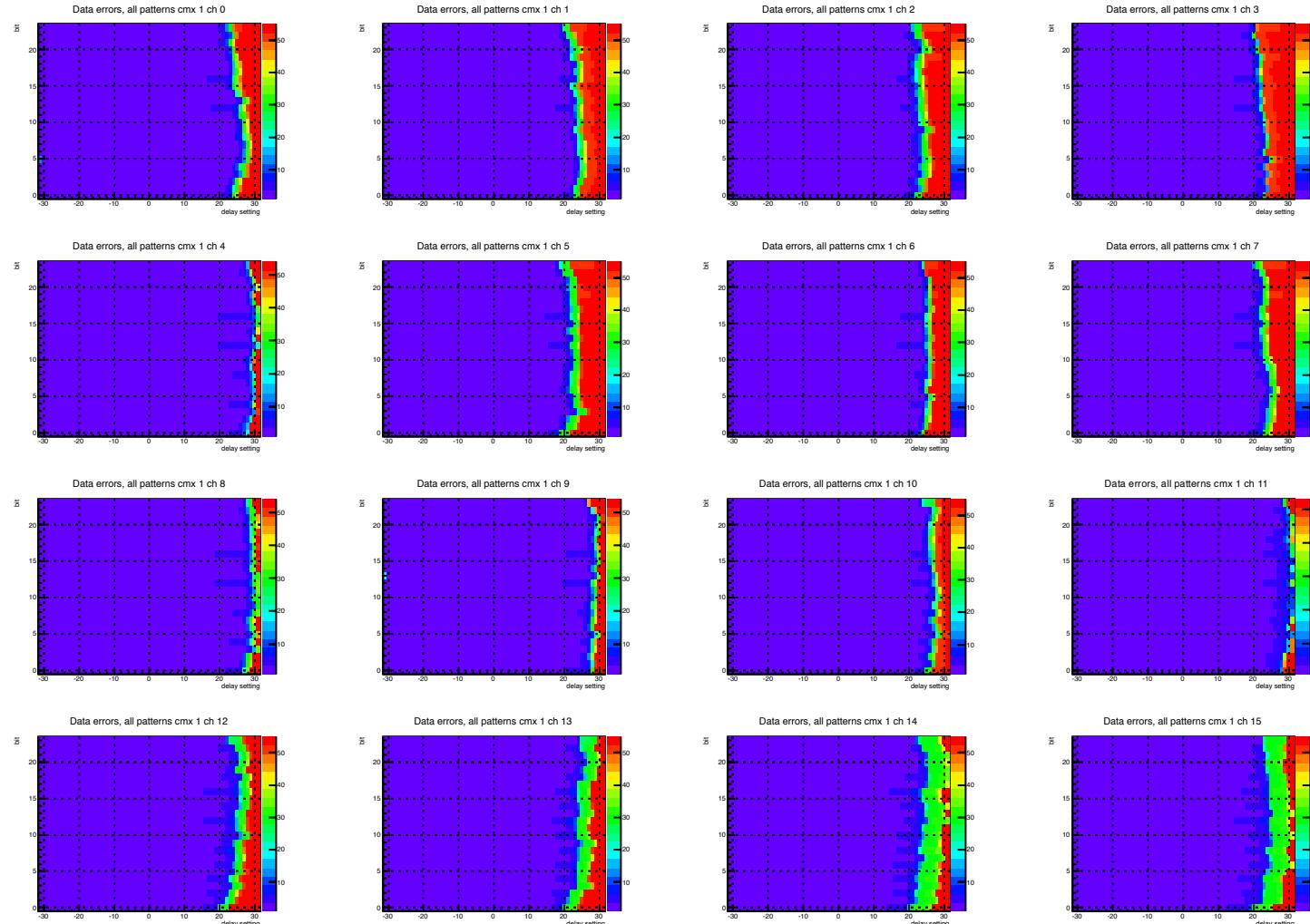
*up to 24th bit...*

# Pretests timing scans JEMs



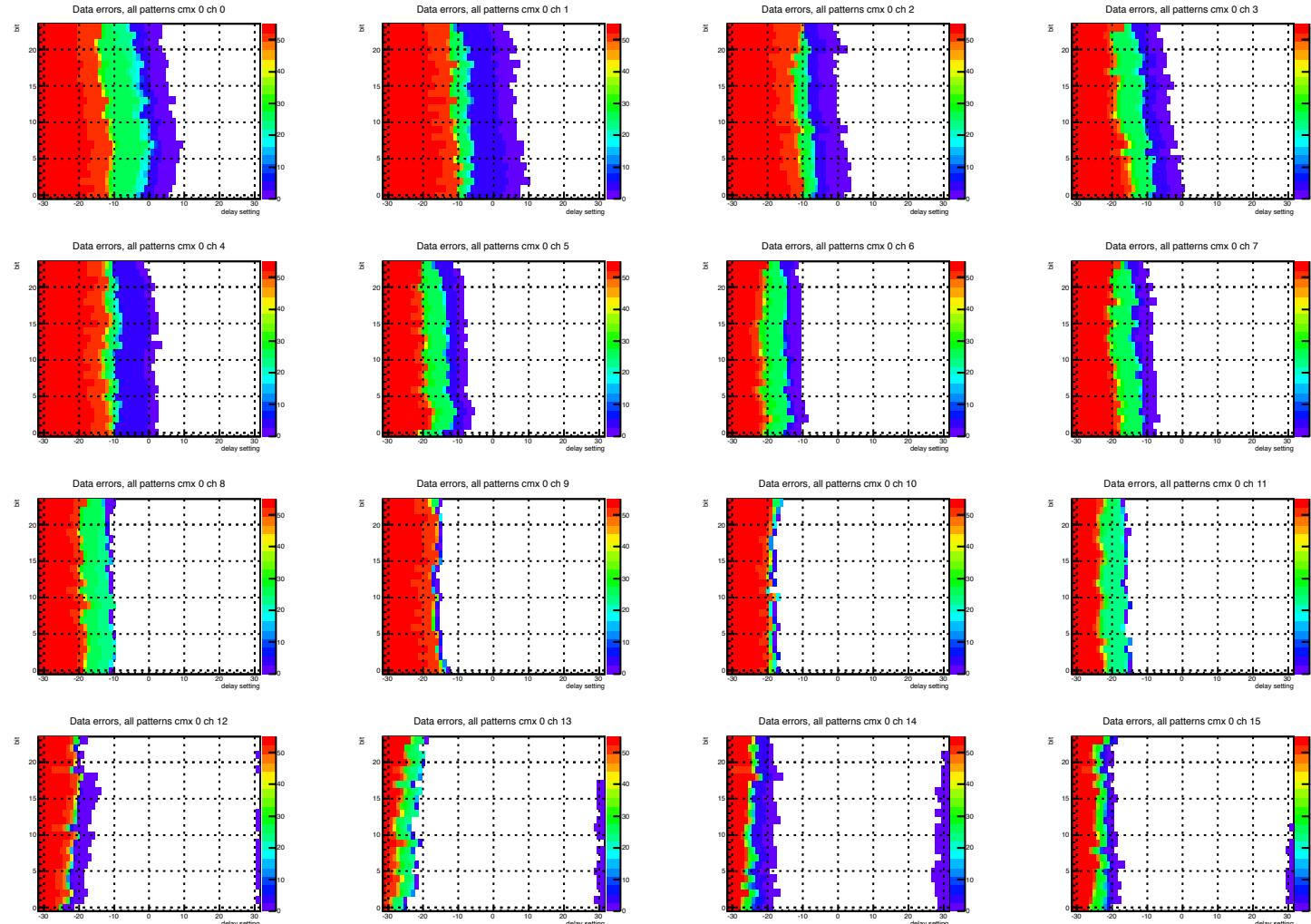
Run #1: CMX0, all patterns, 0.1s dwell time per scan point

# Pretests timing scans JEMs



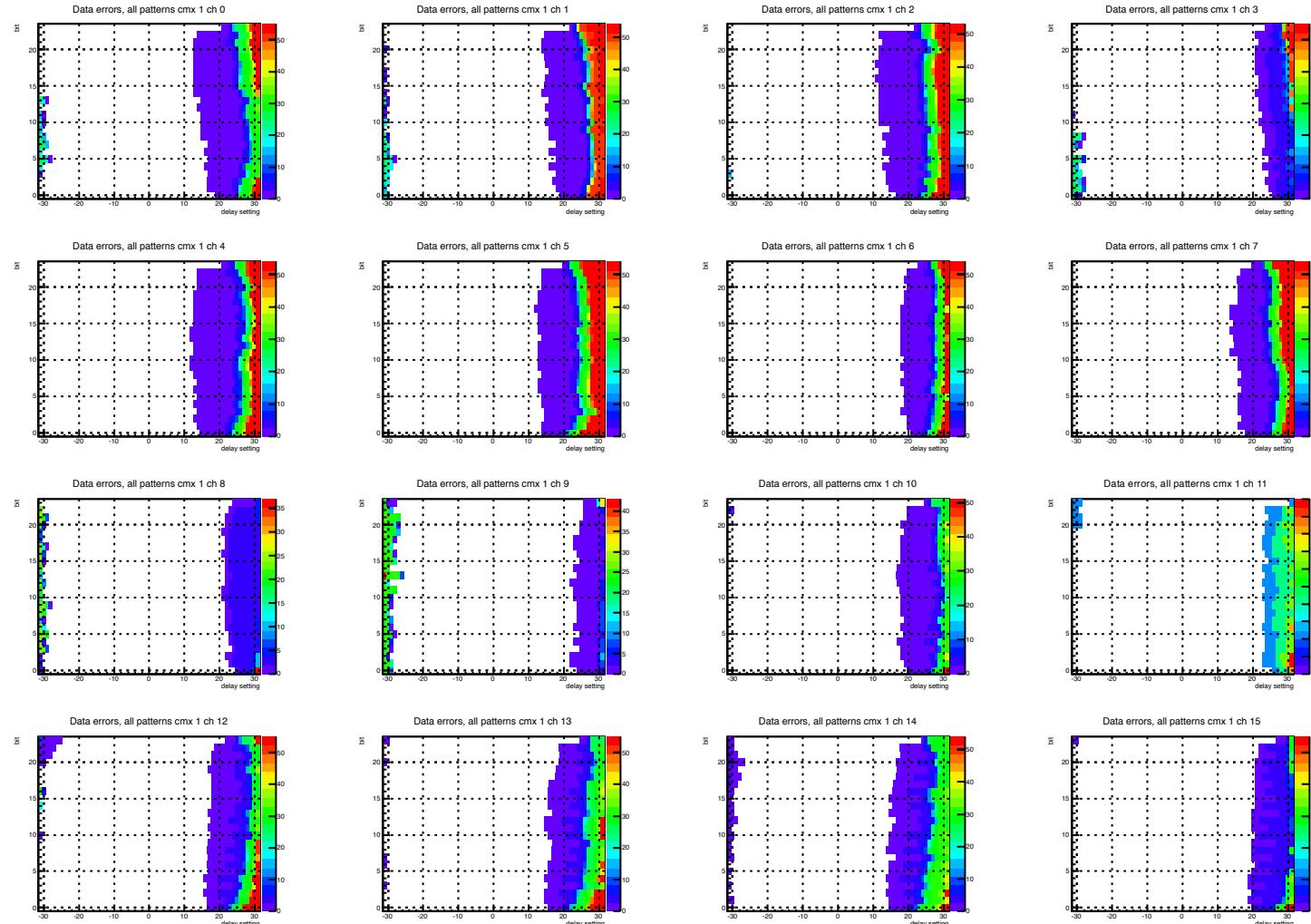
Run #1: CMX1, all patterns, 0.1s dwell time per scan point

# Pretests timing scans JEMs



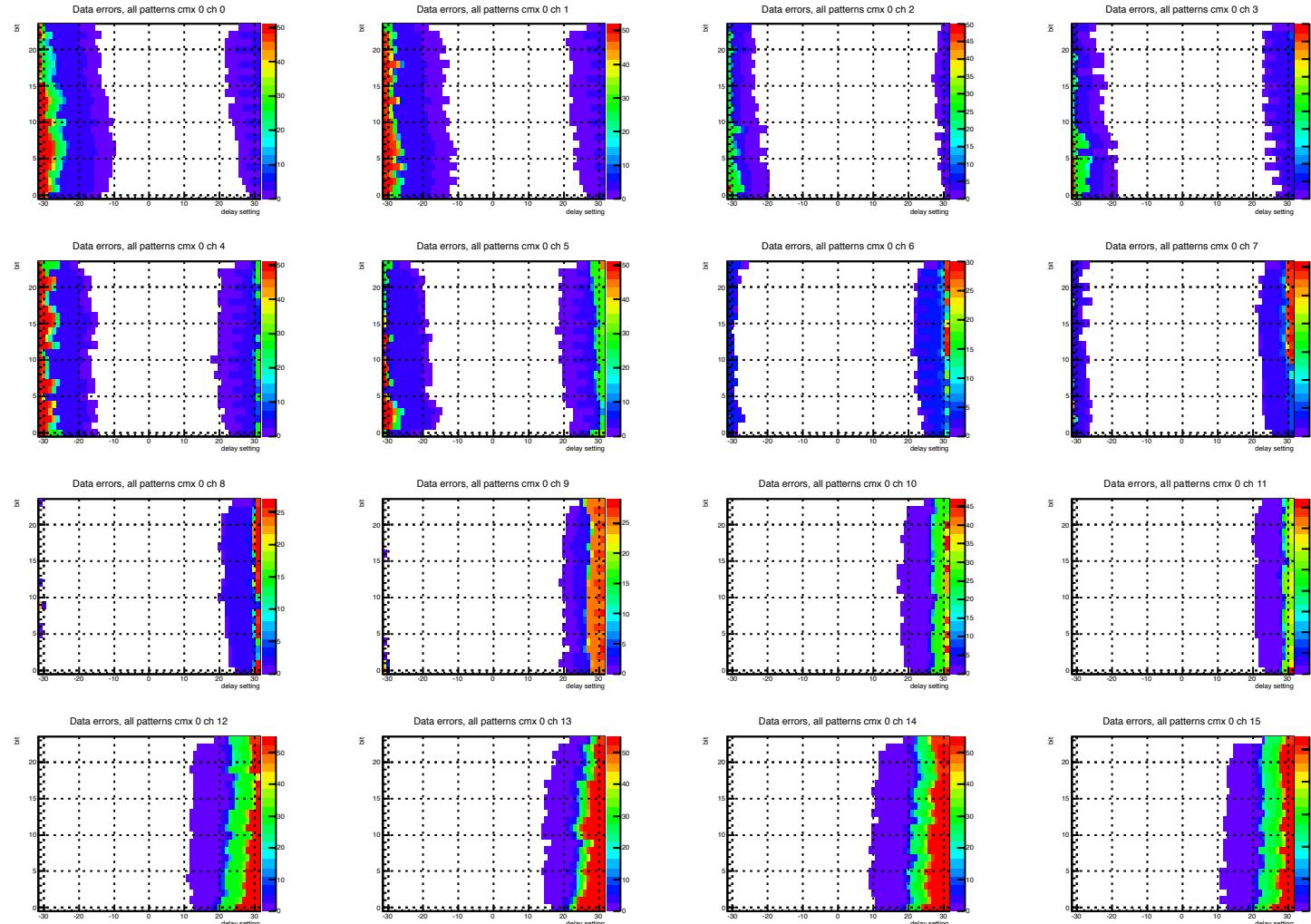
Run #2: CMX0, all patterns, 0.1s dwell time per scan point

# Pretests timing scans JEMs



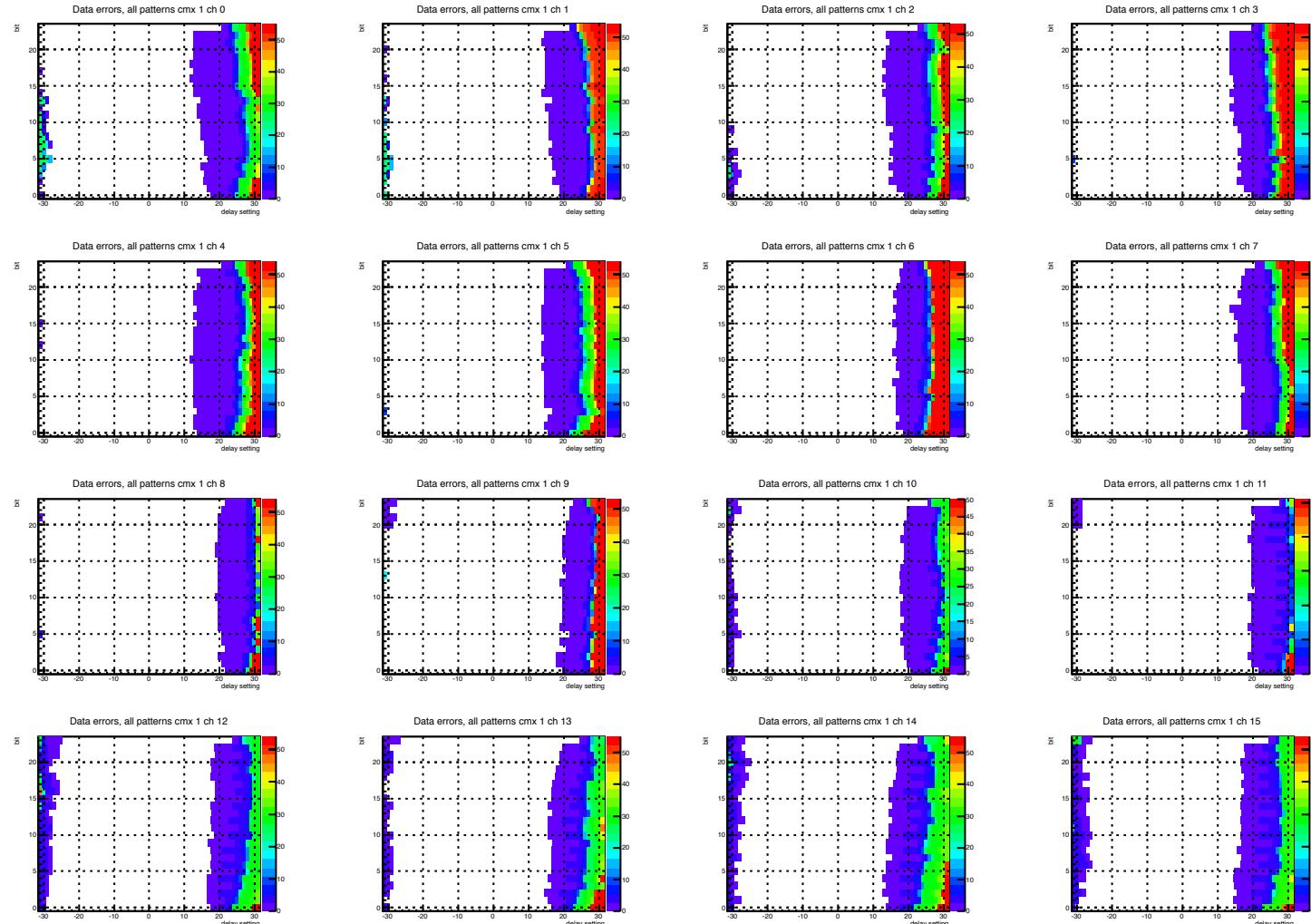
Run #2: CMX1, all patterns, 0.1s dwell time per scan point

# Pretests timing scans JEMs



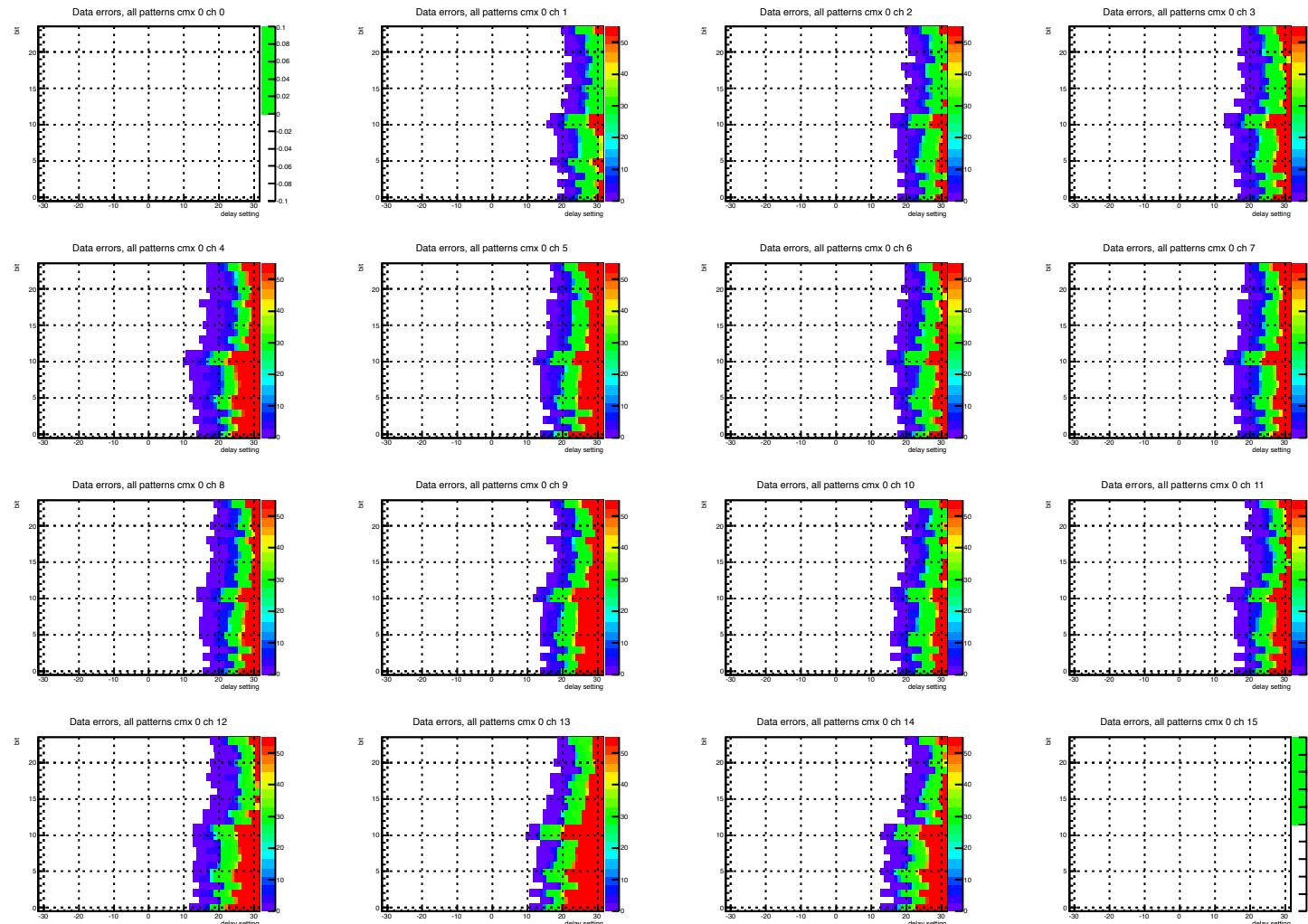
Run #3: CMX0, all patterns, 0.1s dwell time per scan point

# Pretests timing scans JEMs



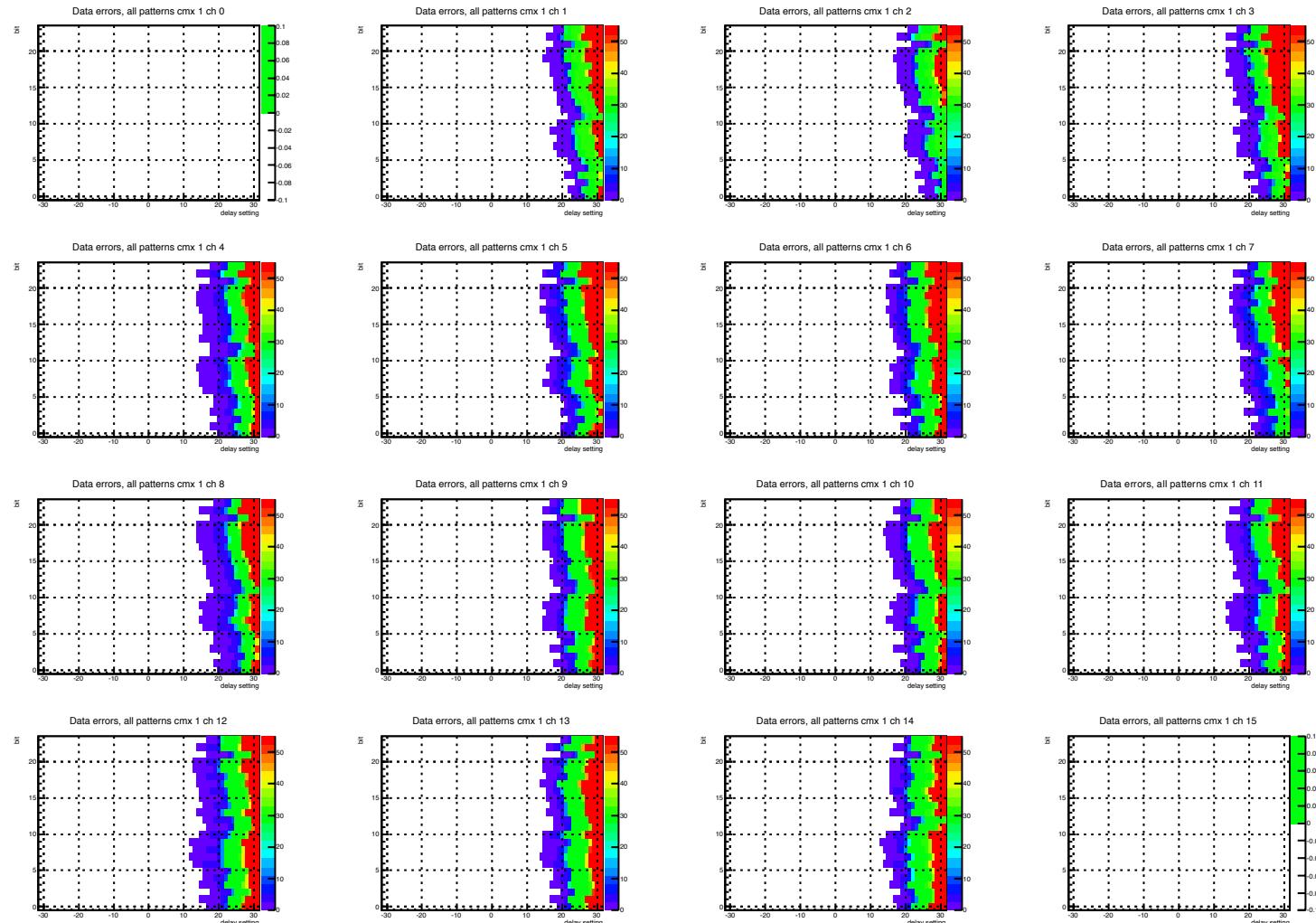
Run #3: CMX1, all patterns, 0.1s dwell time per scan point

# Pretests timing scans CPMs



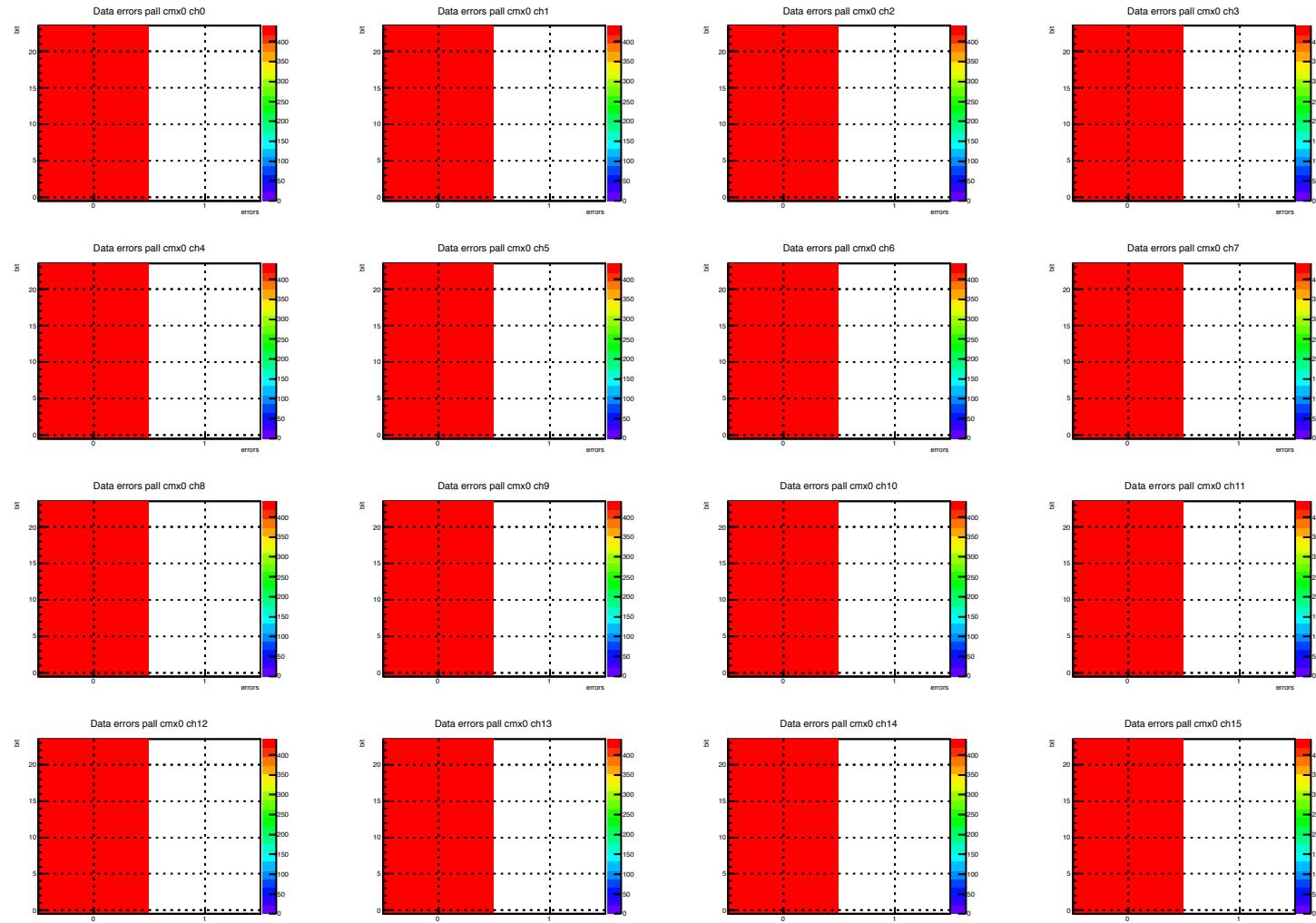
Run #1: CMX0, all patterns, 5s dwell time per scan point

# Pretests timing scans CPMs



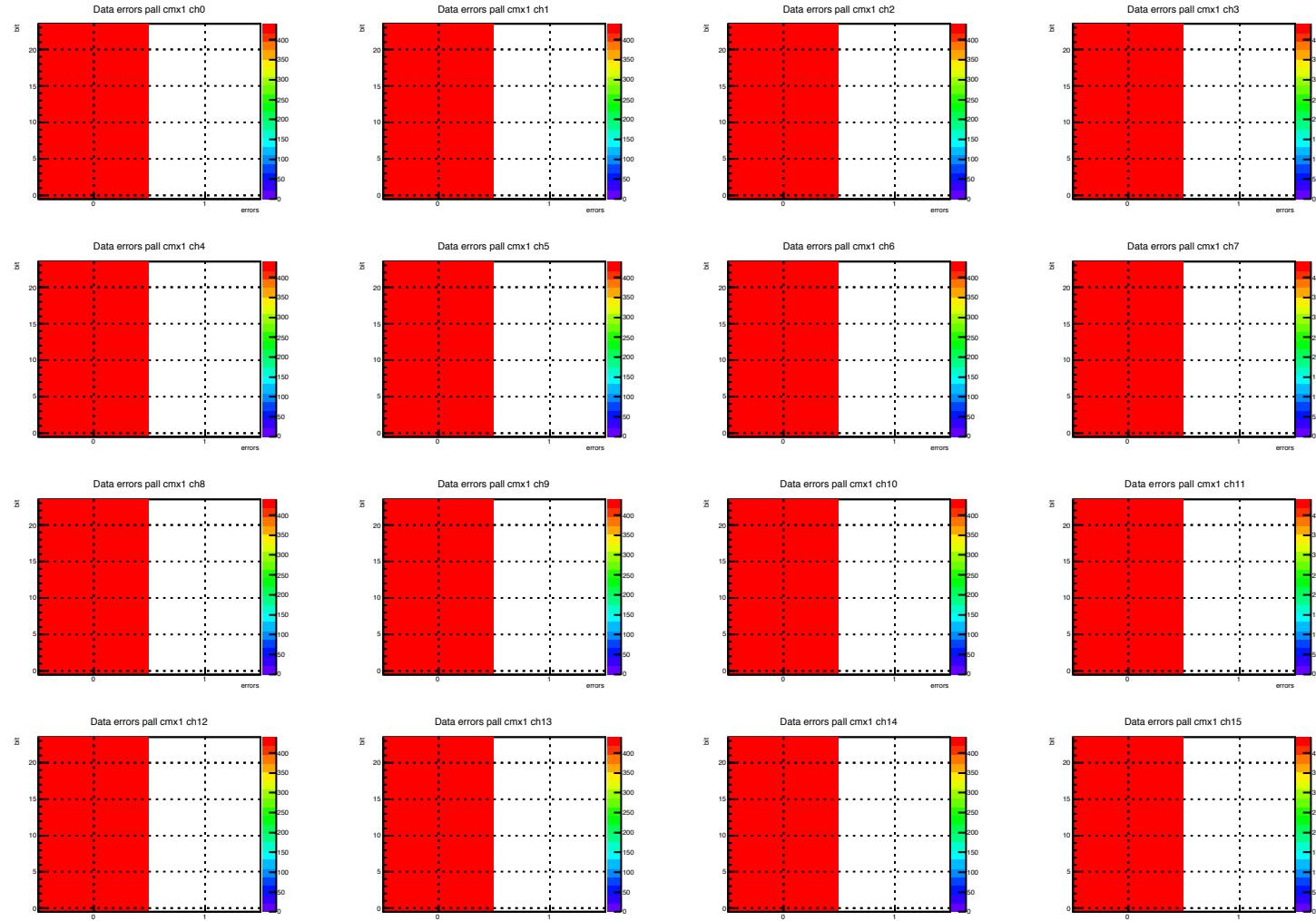
Run #1: CMX1, all patterns, 5s dwell time per scan point

# Pretests long term CPMs



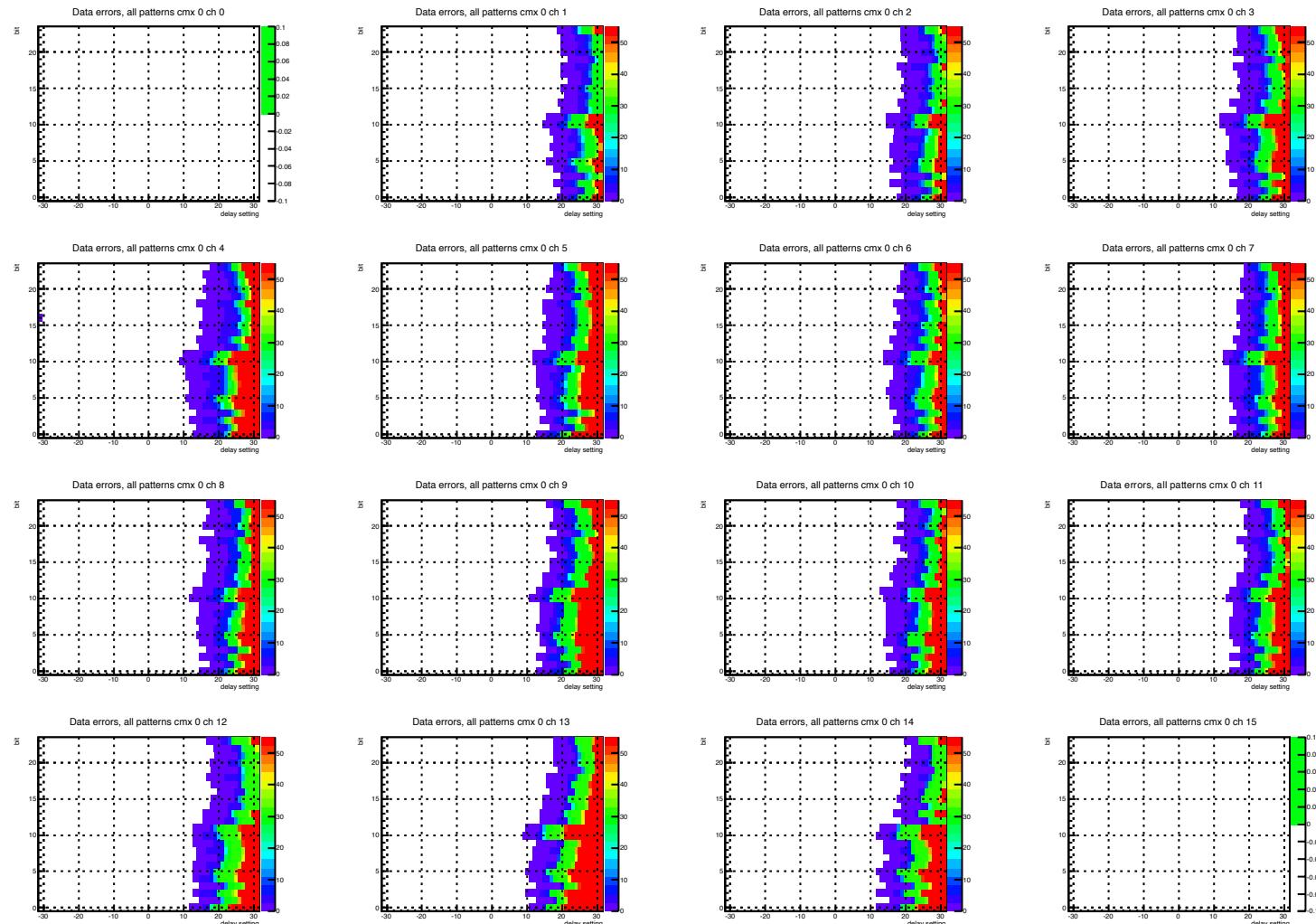
Run #2: CMX0, all patterns, 50s dwell time per scan point

# Pretests long term CPMs



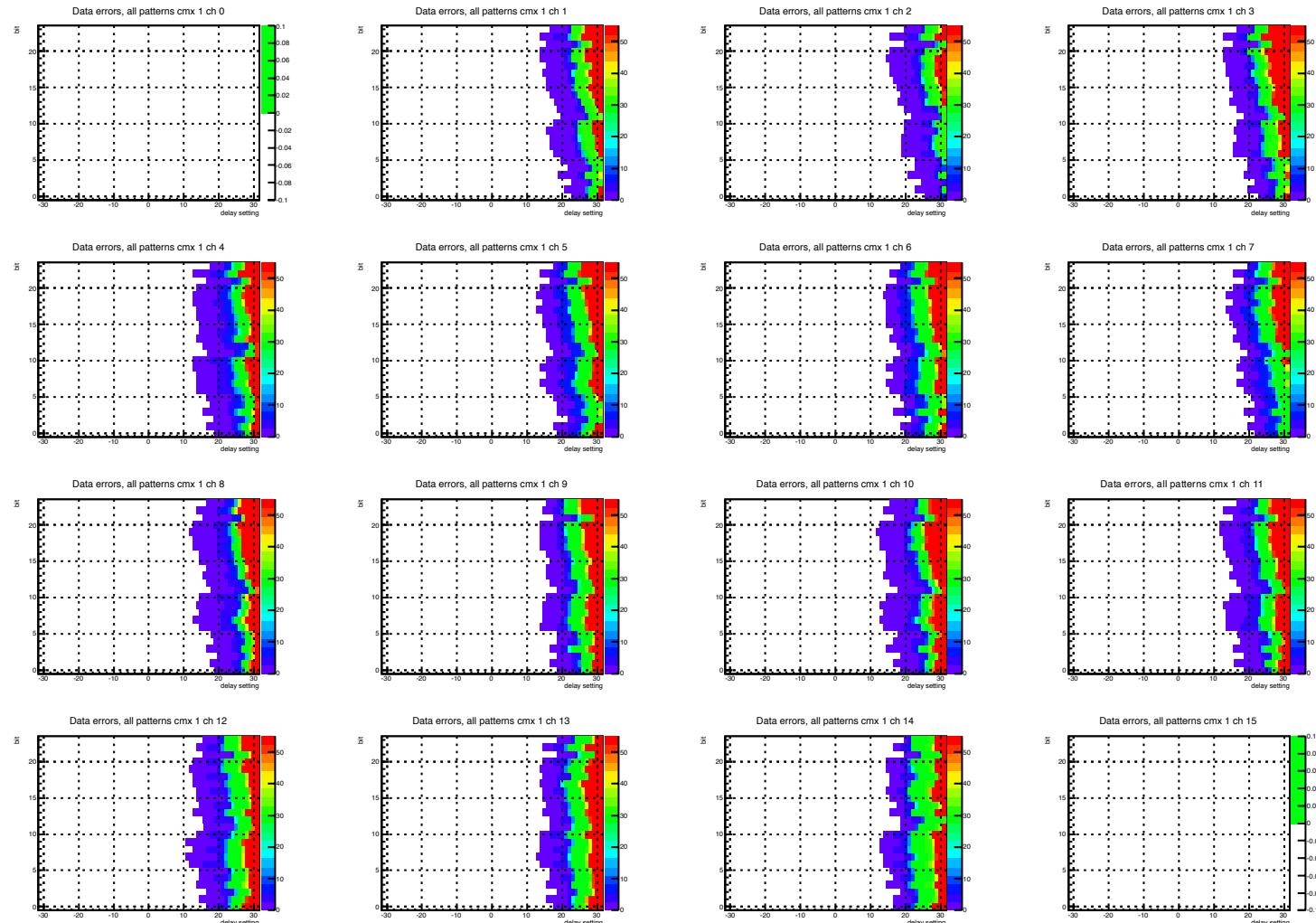
Run #2: CMX1, all patterns, 50s dwell time per scan point

# Pretests timing scans CPMs



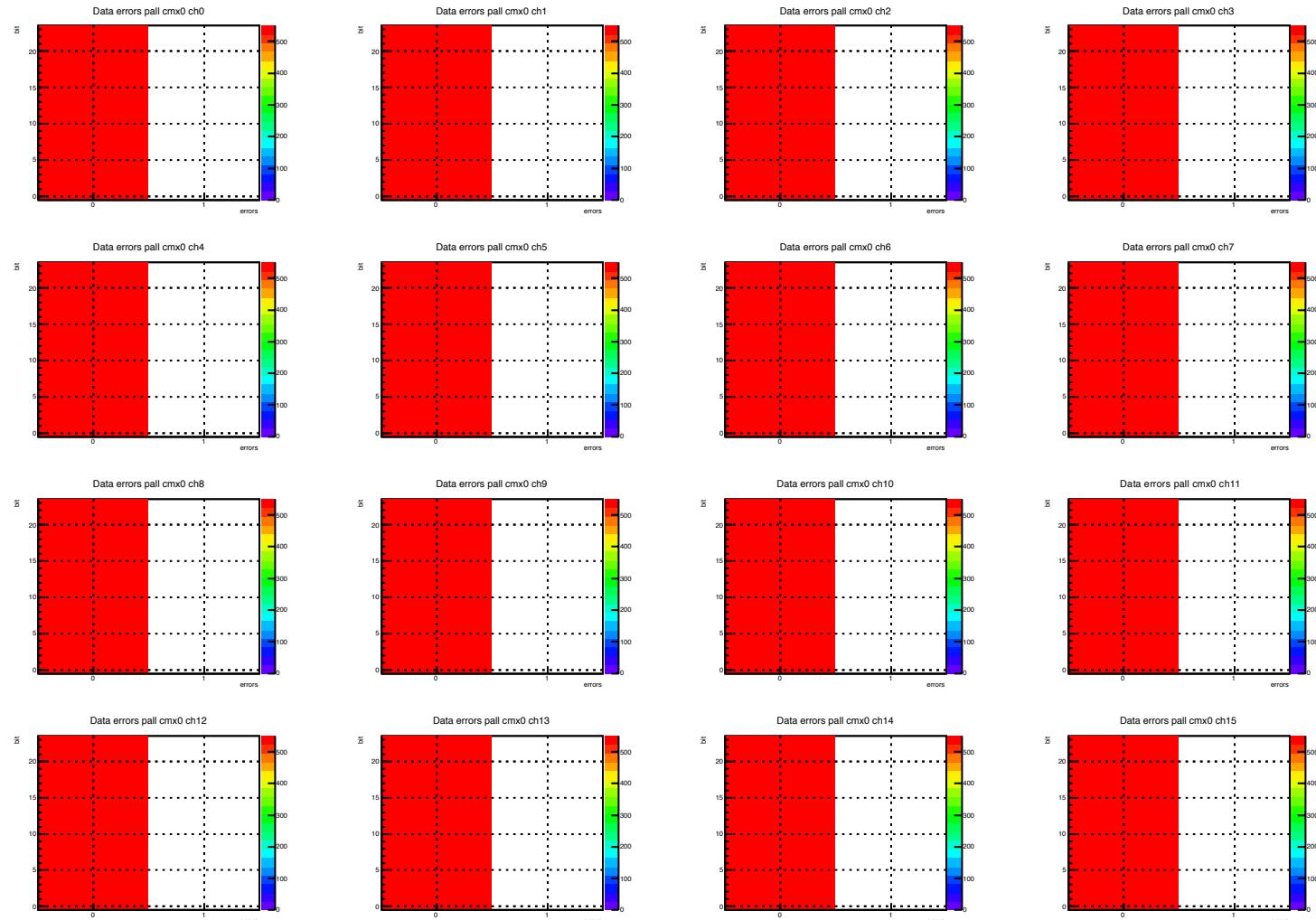
Run #3: CMX0, all patterns, 0.1s dwell time per scan point

# Pretests timing scans CPMs



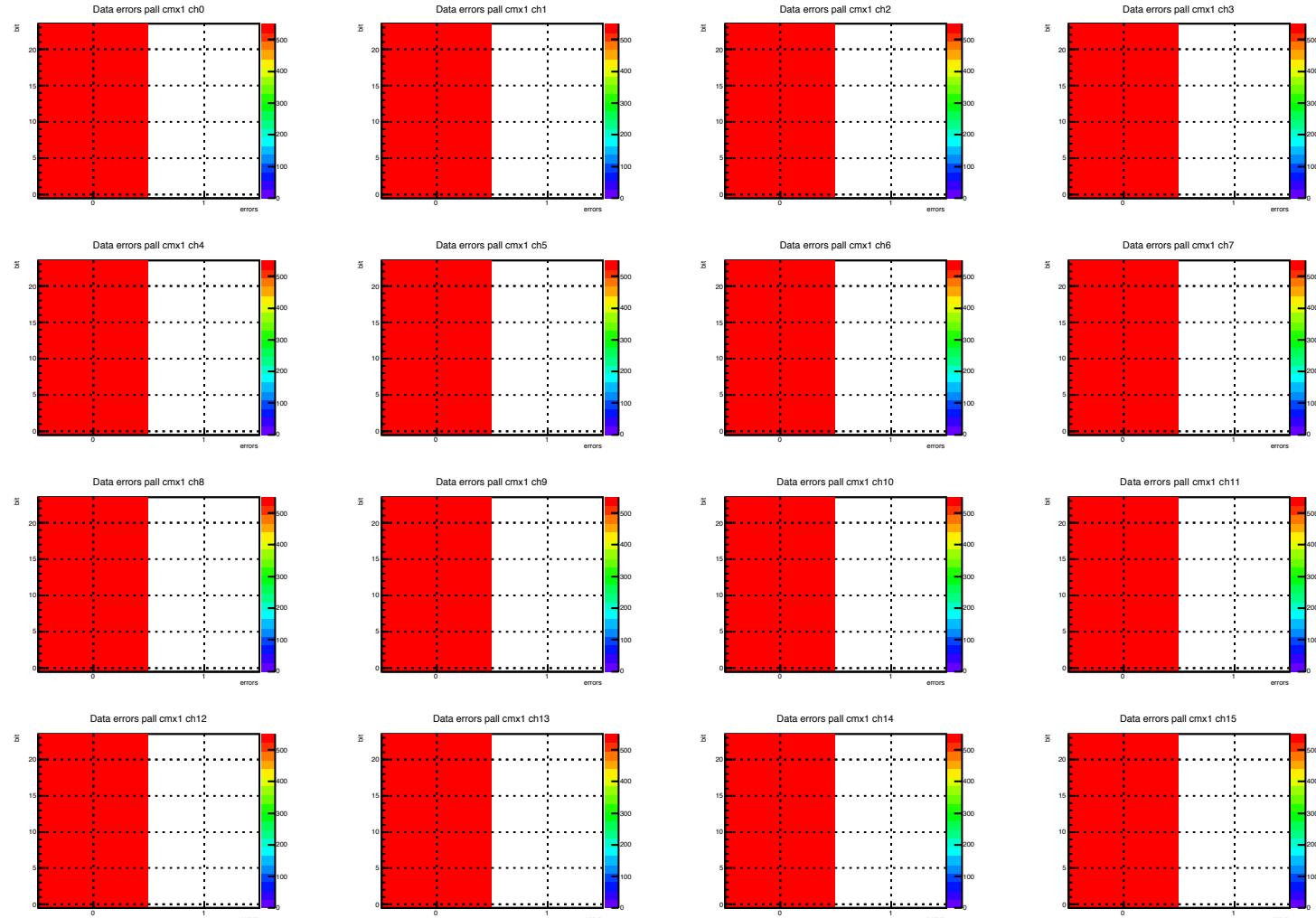
Run #3: CMX1, all patterns, 0.1s dwell time per scan point

# Long term run JEMs



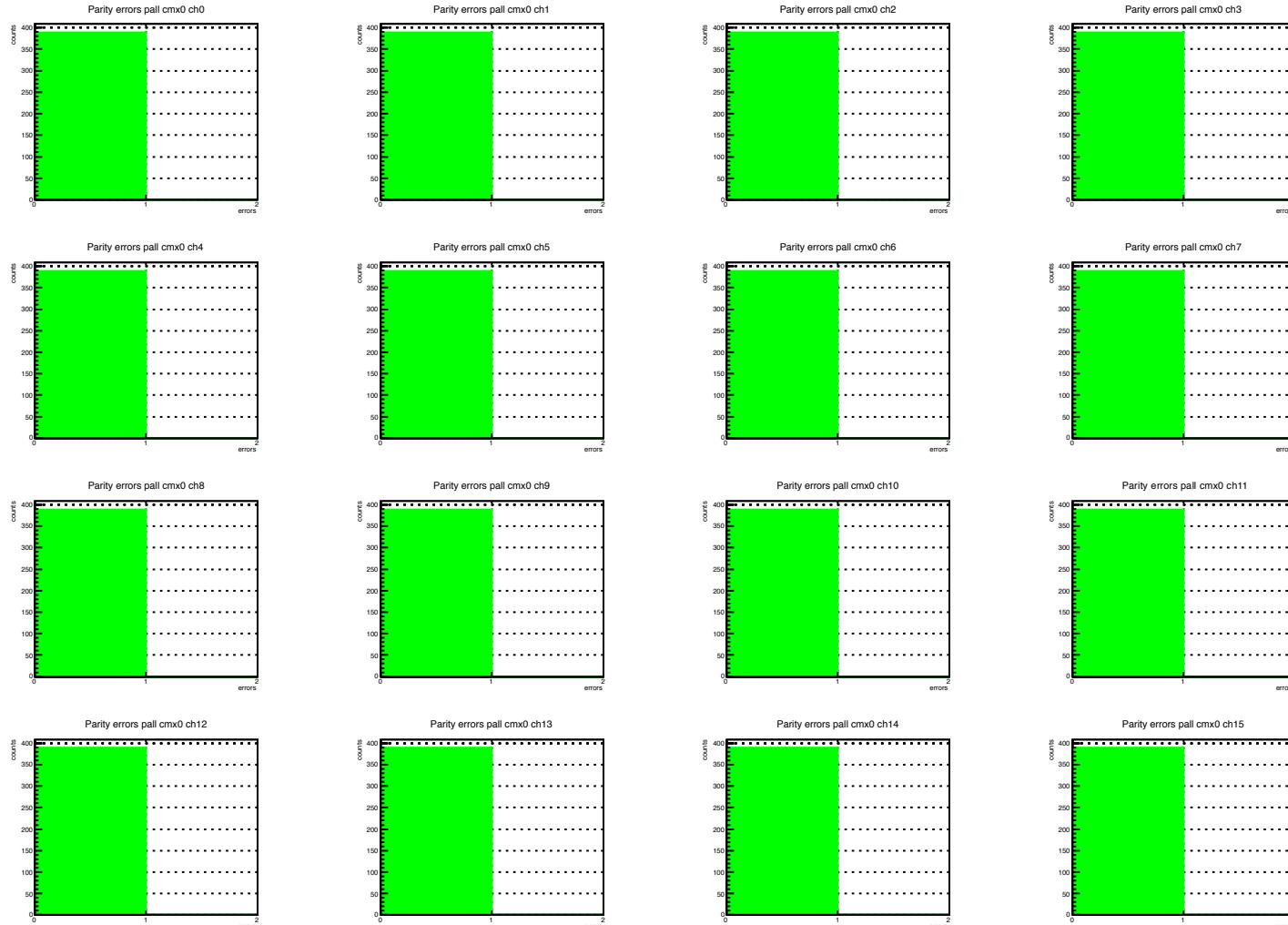
Run #5: CMX0, all patterns, 50s dwell time, 10 cycles at delay 0

# Long term run JEMs



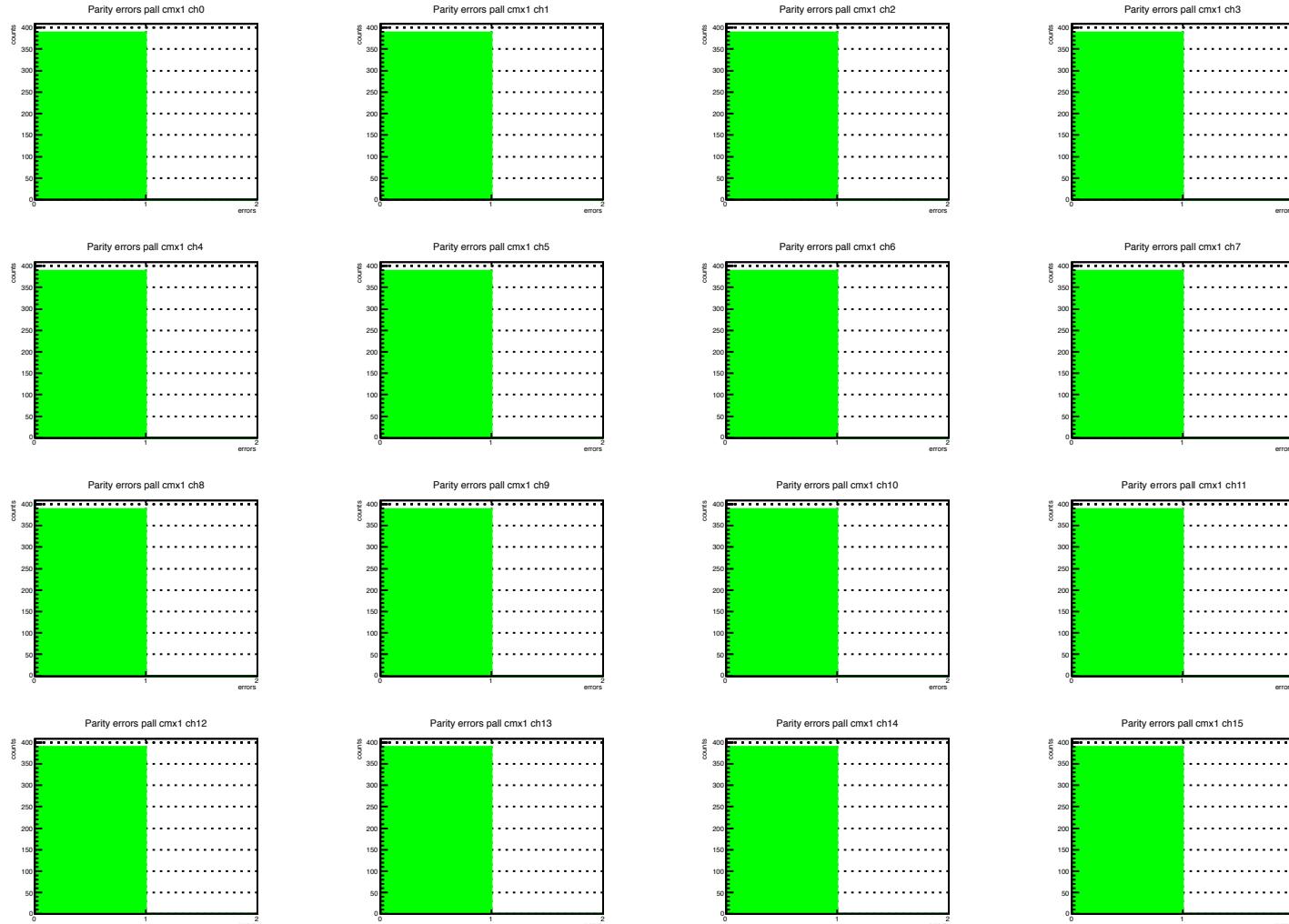
Run #5: CMX1, all patterns, 50s dwell time, 10 cycles at delay 0

# Long term run JEMs



Run 7: CMX0, pseudo-random data, 50s dwell time, 384 cycles at delay 10

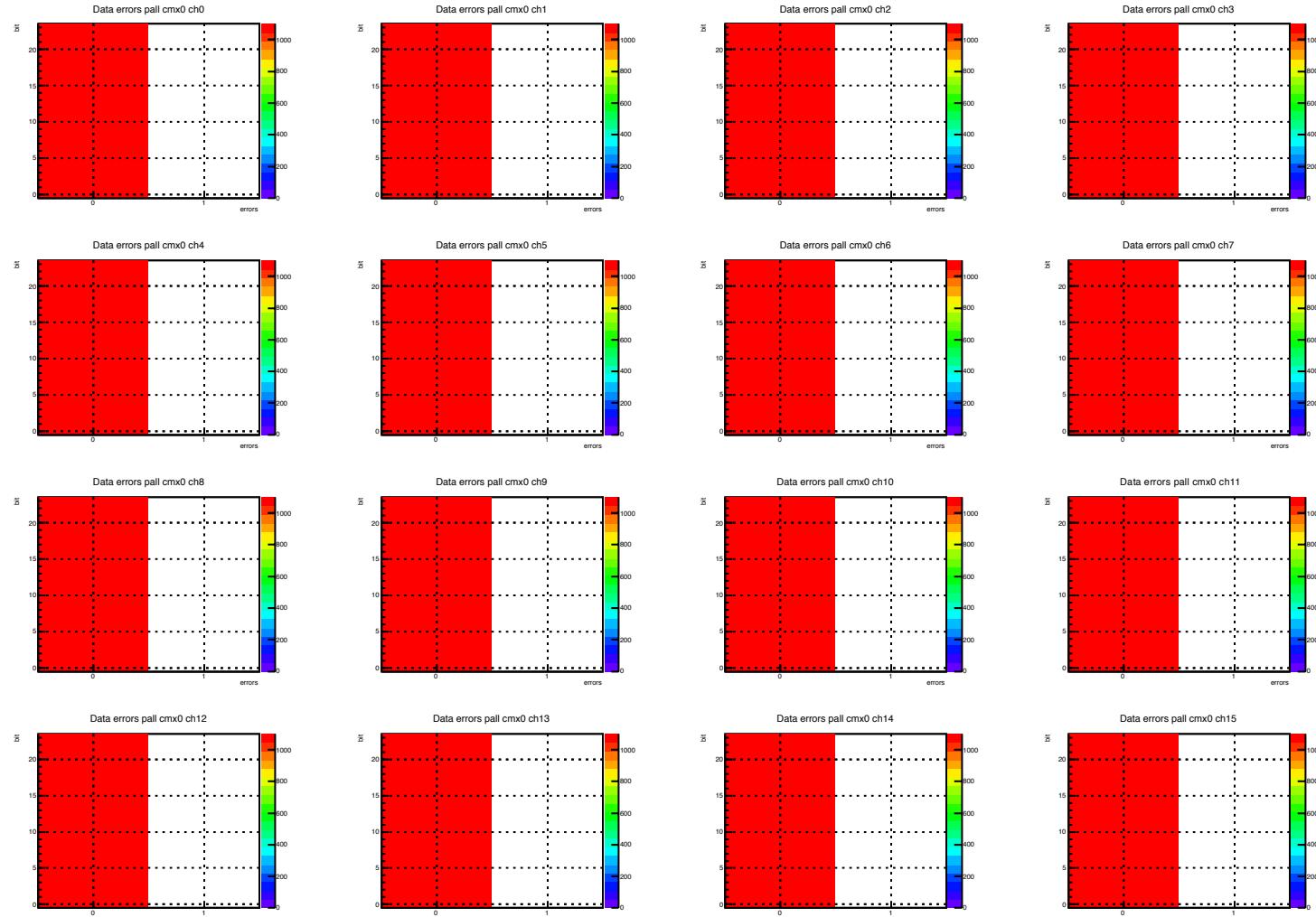
# Long term run JEMs



Run 7: CMX1, pseudo-random data, 50s dwell time, 384 cycles at delay 10

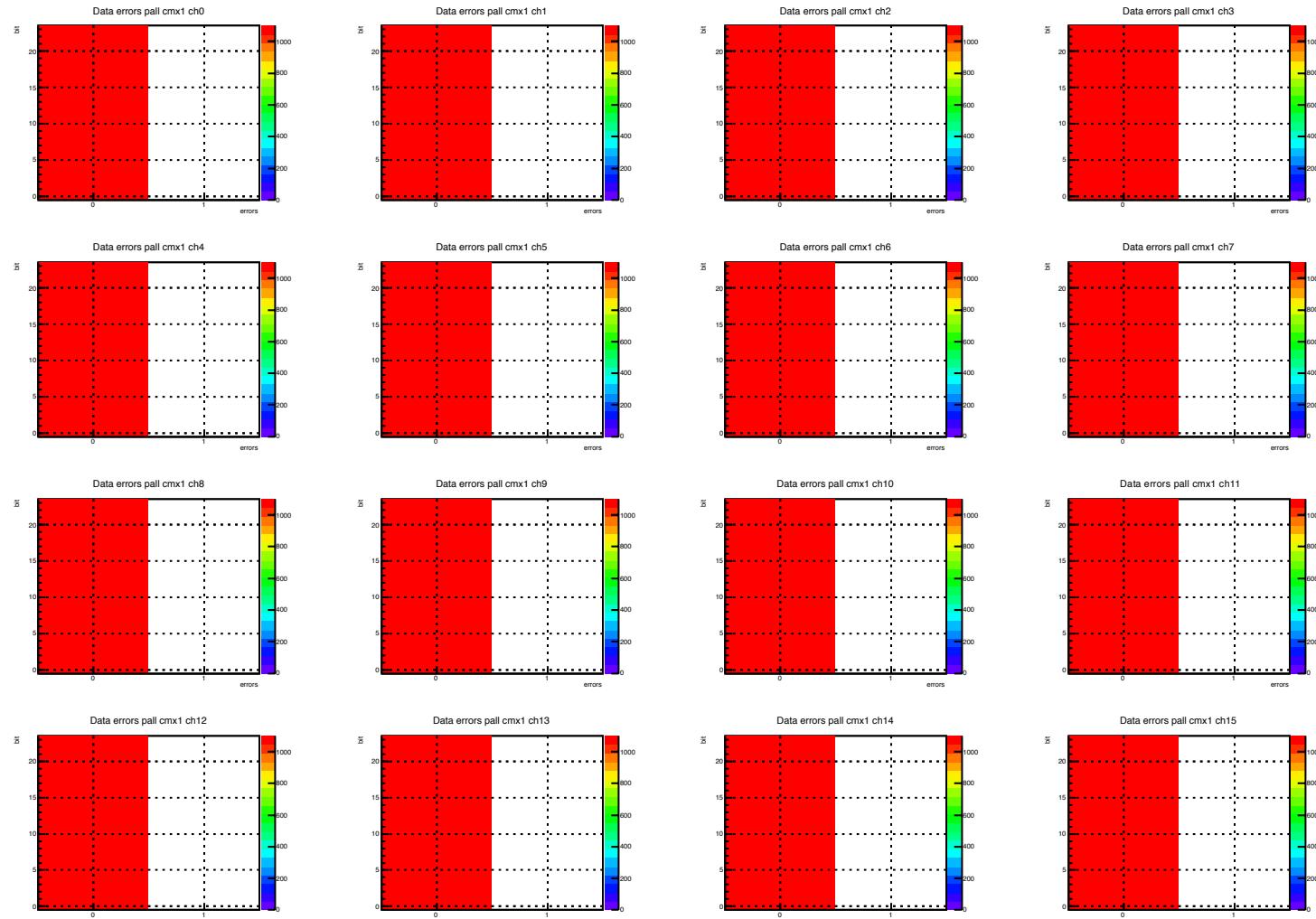


# Long term run CPMs



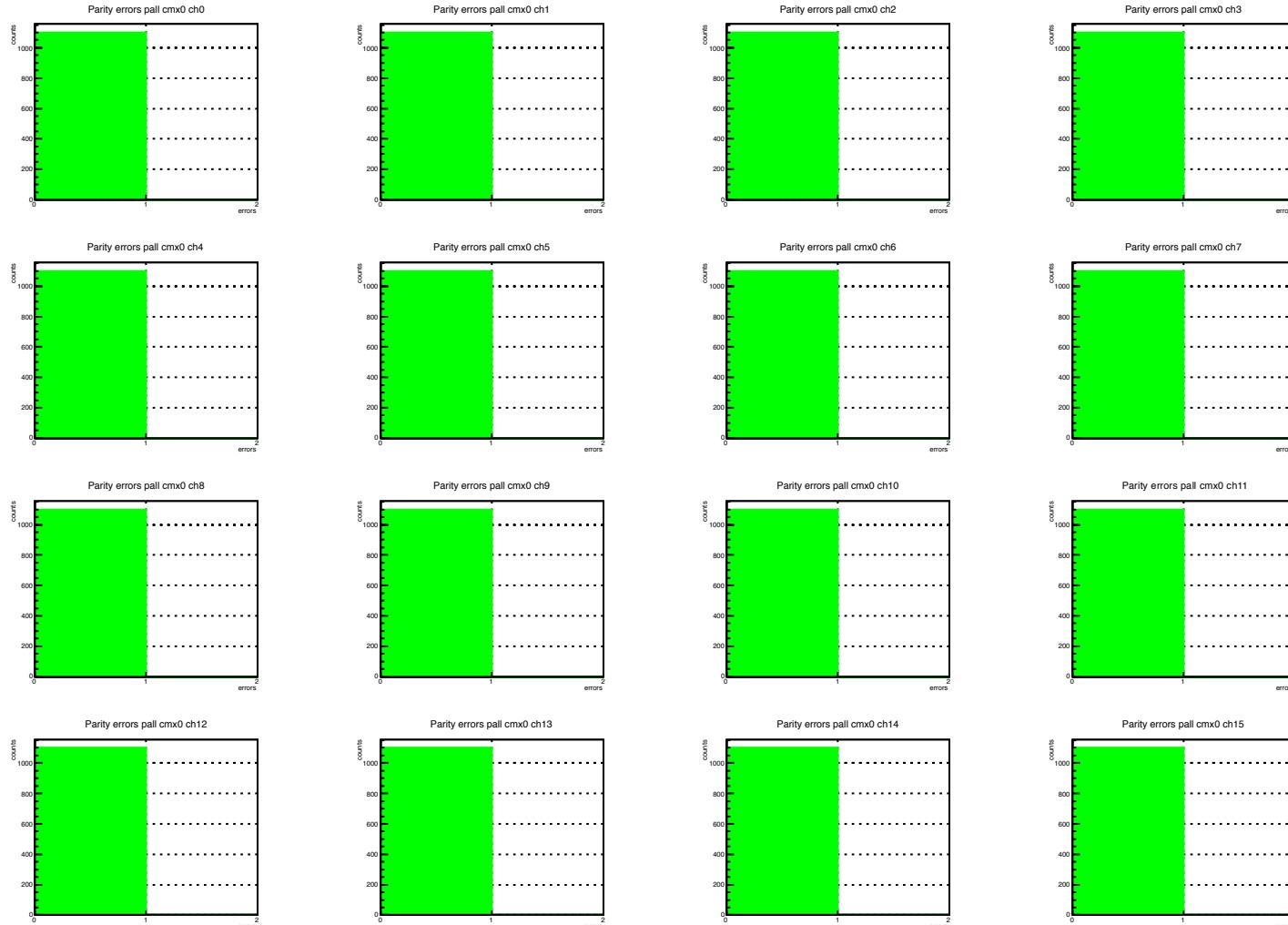
Run #5: CMX0, all patterns, 50s dwell time, 23 cycles at delay -10

# Long term run CPMs



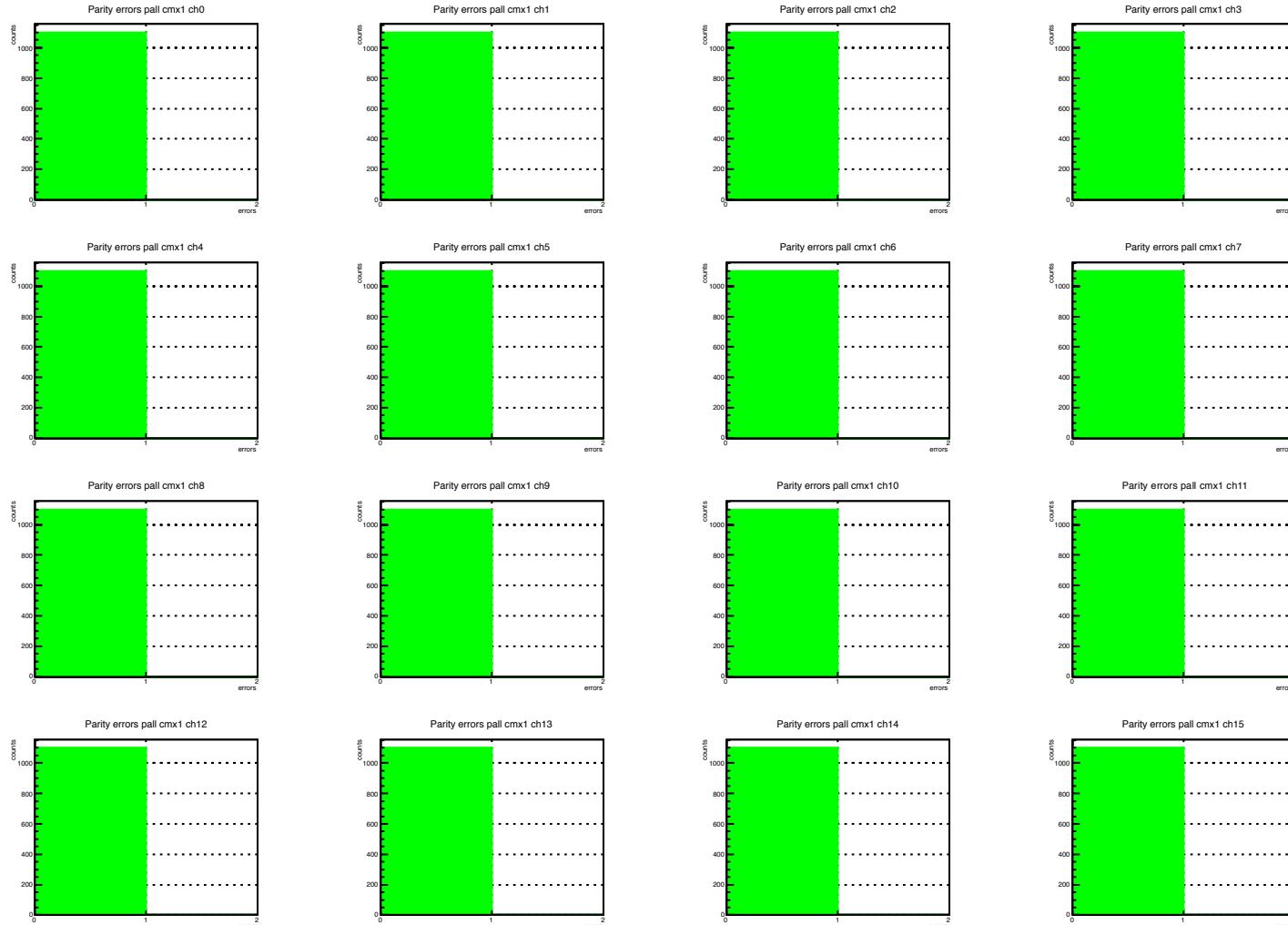
Run #5: CMX1, all patterns, 50s dwell time, 23 cycles at delay -10

# Long term run CPMs



Run #7: CMX0, pseudo-random data, 50s dwell time, 1265 cycles at delay -10

# Long term run CPMs



Run #7: CMX1, pseudo-random data, 50s dwell time, 1265 cycles at delay -10

